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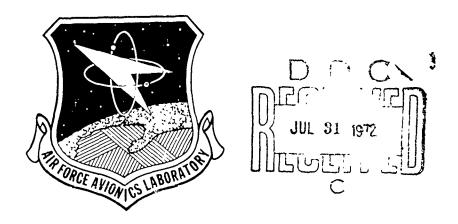
DICHROIC PARAMETRIC MIRROR TECHNIQUES

E. O. Ammann

GTE Sylvania Inc.

TECHNICAL REPORT AFAL-TR-72-177

May 1972



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FOREWORD

This report summarizes the twelve months of work performed on Air Force Contract F33615-71-C-1403 entitled "Dichroic Parametric Mirror Techniques". This work was done on Project Number 6100 under Task number 03. The goal of this work has been to develop and test mirrors which are suitable for use with optical parametric oscillators operating in the region from 1.5 to 4.5 microns. The work which is summarized in this report covers the period from 1 April 1971 through 31 March 1972. This report was prepared by the Electro-Optics Organization of GTE Sylvania Inc., Electronic Systems Group - Western Division, Mountain View, California, and describes work performed in the Research and Development Department headed by Dr. L. M. Osterink. Dr. E. O. Ammann was the principal technical investigator on this program; other contributors include Mr. J. D. Wintemute and Dr. J. M. Yarborough. Technical assistance was provided by Mr. J. D. Wintemute.

The work performed under this contract is administered by the Air Force Avionics Laboratory, Air Force Systems Command, Wright-Patterson Air Force Base, Ohio. Mr. Elgene R. Nichols (AFAL/TEO) is the technical representative on this program for the Avionics Laboratory. This report was submitted by the author in May 1972.

This technical report has been reviewed and is approved for publication.

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ABSTRACT

This report summarizes the results of a twelve-month program whose goal was to develop mirrors which are suitable for use with optical parametric oscillators having outputs in the 1.5 to 4.5 micron region. The properties which such mirrors must have are: (1) low scatter; (2) the correct spectral reflectances at signal, idler, and pump wavelengths; and (3) high resistance to optical damage. The mirrors which were studied on this program were designed for use with a lithium niobate parametric oscillator which is pumped by 1.08 microns. Several different types of multilayer coatings were fabricated and tested. These were ${\rm ZnS-ThF}_4$, ${\rm ZnS-ThF}_4$ overcoated with ${\rm Al}_2{}^0{}_3$, ZnS-cryolite, ZnS-cryolite overcoated with ${\rm Al}_2{\rm O}_3$, ZnS-ThF $_4$ undercoated and overcoated with ${\rm Al}_2{\rm O}_3$, and a "hard coating" of unknown composition. The tests which were performed on each coating included (1) microscopic inspection to determine scatter properties, (2) spectrophotometer traces to determine spectral transmittance, (3) 1.08 micron damage threshold tests, and (4) operation of an optical parametric oscillator using the coatings. Best overall results were obtained with mirrors composed of ${\rm ZnS-ThF}_4$ undercoated and overcoated with $\mathrm{Al}_2\mathrm{O}_3$. Measurements were also performed to determine the surface-damage thresholds of uncoated and coated lithium niobate; it was found that both soft (e.g. ZnS, ThF $_4$, cryolite, etc.) and hard (e.g. ${
m Al}_2{
m O}_3$) coatings raise this threshold, with the greatest improvement effected by the ${\rm Al}_2{\rm O}_3$ coating.

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Section I

INTRODUCTION

The object of this program has been to study means of improving the characteristics of mirrors which are used with optical parametric oscillators. This work was motivated by the realization that better oscillator mirrors would produce improved parametric oscillator performance. GTE Sylvania was the prime contractor on this program with overall technical responsibility for specifying and evaluating the oscillator mirrors. Lambda Optics and Coating, Inc. performed the mirror fabrication as a subcontractor. This final report summarizes the results obtained on this program covering the period from 1 April 1971 to 1 April 1972.

Optical parametric oscillation is obtained by "pumping" a nonlinear crystal with an intense laser beam. Signal and idler waves originate in the crystal from noise and interact parametrically with the pump to produce two outputs at new frequencies. The nonlinear crystal is placed in an optical cavity that is resonant at either one (singly-resonant oscillator) or both (doubly-resonant oscillator) the signal and idler wavelengths. Parametric oscillator mirrors must therefore have specified reflectances at three different wavelengths - the signal, idler, and pump. This is a much more difficult problem than the situation encountered with laser mirrors where only a single wavelength is involved.

Correct spectral reflectance is just one of several criteria which parametric oscillator mirrors must meet, however. On this program, we have sought to develop mirrors which (1) have the correct reflectances at signal, idler, and pump wavelengths; (2) have very little scatter; and (3) have high resistance to optical damage. Let us briefly consider each of these below.

(1) Spectral Reflectance: In a doubly-resonant parametric oscillator, the coatings should be highly reflecting (or at most, slightly transmitting) at both the signal and idler wavelengths. The coatings should also be transmissive (80% or more) at the pump wavelength. The need for high reflectivity (HR) at two different wavelengths will, in general, require two HR stacks to

than usual will be needed for oscillator mirrors, and this can lead to such problems as stress (and subsequent crazing) in the coatings or excessive scatter. We see already that the three desired mirror properties mentioned above are not independent, but rather are interrelated to a considerable degree.

In a singly-resonant oscillator, the coatings need be HR at the signal wavelength and transmitting at the idler and pump wavelengths. This is an easier situation to achieve, and does not require as many layers of dielectric material in the stack as do doubly-resonant coatings.

Fairly standard mirror design techniques were employed in this work. The difficulties encountered in realizing suitable mirrors are often practical ones, such as the presence of large numbers of layers in the coating, or the ucilization of materials which do not behave in a completely predictable fashion during deposition.

which were previously commercially available is that they contained excessive numbers of scatter centers. Scatter centers in coatings are caused by the presence of discrete particles in the thin-film layers that compose the mirror. The reasons for the presence of these particles has not been clearly understood. Suspected sources have included dust particles in the coating chamber, fine particles in the vapor stream, and the polycrystalline nature of the deposited film layers. Very few investigators have previously addressed themselves to this problem. Perry has suggested and implemented some practical approaches to reducing scatter in zinc sulfide-thorium fluoride laser mirrors. Forbes and Fraser have studied scatter and stresses in He-Ne laser mirrors using zinc sulfide, cryolite, and magnesium fluoride. We have considered the reduction of coating scatter to be a major goal of this program.

A word should be mentioned here about why the reduction of scatter losses from coatings is important. In a doubly-resonant optical parametric oscillator, threshold is inversely proportional to the single-pass signal and

idler losses of the resonator . In an external oscillator configuration (nonlinear crystal situated outside the pump laser), scatter centers in the mirrors act as losses to the signal and idler waves (because energy is scattered out of the resonant modes of the resonator) thereby raising threshold for the oscillator. In an internal oscillator (nonlinear crystal situated inside the pump laser), scatter losses are detrimental for two reasons, rather than one. As with the external oscillator, threshold is raised due to signal and idler losses. In addition, mirror scatter losses will reduce the available pump power because these mirrors are situated inside the pump laser. The scatter levels were sufficiently bad in some of the mirrors which were commercially available prior to this program that it would often not be possible to reach oscillator threshold with a doubly-resonant oscillator.

There is another reason why it is advantageous to reduce the scatter level in coatings. Scatter particles are, in effect, imperfections in the coating; thus laser damage may occur at a lower level than in a perfect coating. Thus it is possible that there is a relationship between the scatter properties and the laser damage threshold of a coating. Bennett 8, for example, has found that metallic or dielectric inclusions in laser glass are a prime source of rod damage.

(3) Damage Thresholds: As the average and peak power outputs of parametric oscillators continue to grow, mirror and crystal damage has become more and more of a limitation on oscillator performance. On this program, we have measured damage thresholds for the various types of mirrors which were fabricated. In addition, the selection of coating materials was made with an eye toward achieving high damage thresholds.

Several investigations have previously been carried out on damage thresholds of laser coatings. Steinberg, et al have studied ruby laser damage thresholds for various combinations of coating materials. They conclude that "soft" coating materials having low residual stresses are most durable. 10 Turner has also studied ruby laser damage in various types of coatings. Turner suggests that absorption and subsequent thermal effects lead to damage. The limited and sometimes conflicting data which exist have prompted us to carry out our own investigations of coating damage. This allows us to duplicate in our damage experiments the exact conditions (wavelength, pulse duration, repetition rate, etc.) which exist during parametric oscillator operation.

The motivation for this mirror program came in large part from optical parametric oscillator work which was sponsored by Wright-Patterson Air Force Base and which was performed by the Electro-Optics Organization of GTE Sylvania in Mountain View, California. This work was performed under contracts No. F33615-69-C-1702 and F33615-71-C-1642 covering the period from May 1969 through the present. The object of these programs was to generate tunable outputs in the 2 to 5 micron region of the spectrum. Lithium niobate crystals were pumped by the 1 micron output of a Nd laser to achieve the desired outputs.

The mirrors which we have studied on this program are appropriate to the above type of optical parametric oscillator and its wavelength range. This does not mean, however, that the results of this program are only of limited use. The techniques and materials which were studied are, in general, useful throughout the entire visible spectrum and the near infrared. However the specific designs which were used, and the tests which were performed were for the 2 to 5 micron oscillator. A more complete description of that oscillator will now be given.

The oscillator can be operated in either of two forms, external or internal. The external configuration is shown in Fig. 1. The 1.08 micron output from a continuously pumped, repetitively Q-switched Nd:YAlO₃ laser is focused (by means of a 10 cm lens) into a lithium niobate crystal. The crystal is cut with its optic axis at an angle of 45 degrees with respect to its end faces in order to achieve phase matching near room temperature. The crystal used is about 4mm long and is antireflection coated. A temperature-controlled copper oven houses the crystal. The external oscillator resonator consists of two mirrors which are highly reflecting at the signal and idler wavelengths. The resonator is near-hemispherical with the flat mirror placed within a millimeter or so of the crystal. The output mirror has a radius of curvature of 5 cm and is placed approximately 5 cm from the flat mirror. In the external oscillator configuration, the mirrors are deposited on fused quartz substrates.

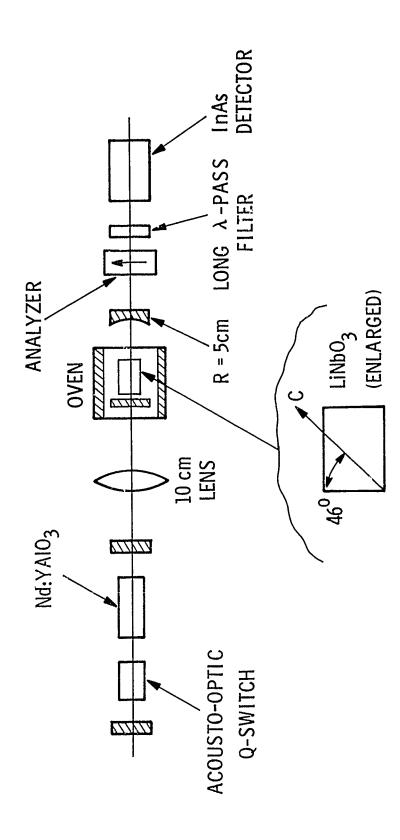


Figure 1 External Optical Parametric Oscillator

The internal oscillator configuration is pictured in Fig. 2. The Nd:YAlO₃ pump laser resonator is formed by two flat mirrors spaced about 45 cm apart. The laser mirrors are highly reflecting at the pump wavelength of 1.08 microns while transmitting about 85% at the signal and idler wavelengths. A lithium nicbate crystal, housed in a temeprature-controlled oven, is placed within the laser resonator. The oscillator mirrors are coated directly onto the plane-parallel end faces of the crystal. Thus the internal configuration requires mirrors to be coated on lithium niobate whereas the external configuration requires mirrors on fused quartz substrates. For this reason, both lithium niobate and quartz substrates were used with each of the coatings investigated on this program.

The remainder of this report is organized in the following manner. Section II is concerned with the types of mirrors that were investigated. Coating materials which were employed are discussed along with the mirror designs which were used. The coating procedures which were used by Lambda Optics are described in Section III. Also covered in Section III are the techniques used by Sylvania in evaluating and testing the oscillator mirrors. Sections IV, V, and VI give the results of our scatter, spectral transmittance, and damage threshold tests, respectively, for the various types of mirrors. In Section VII, the results of optical parametric oscillator experiments employing these coatings are given. Data on oscillator output power and coating damage under actual operating conditions are given. Conclusions reached on the mirror program are given in Section VIII along with recommendations for further work. Finally, references are listed in Section IX.

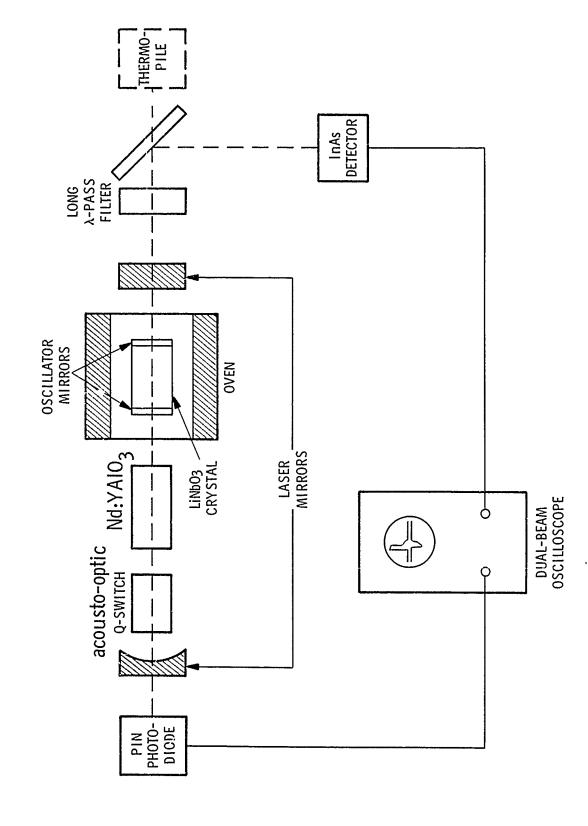


Figure 2 Internal Optical Parametric Oscillator

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Section II

COATING MATERIALS AND MIRROR DESIGNS EMPLOYED

Several different combinations of coating materials were investigated on this program in an effort to find an optimum pair for the realization of parametric oscillator mirrors. In this section we discuss the coating materials selected, the substrates used, and the designs used in fabricating the mirrors.

2.1 COATING MATERIALS

A large number of different materials have been used in various optical thin-film applications 11 . Probably the four materials which have received the most attention as laser mirror coatings in the literature are zinc sulfide (Zhō), zinc selenide (Zhōe), thorium fluoride (ThF4), and cryolite (Na3AlF6). On this program, the materials studies were selected according to our expectation that they would (1) produce a low-scatter coating; (2) have a high damage threshold; and (3) produce the desired spectral reflectances. These priorities are listed in decreasing order of importance.

2.1.1 ZnS - ThF₄

A combination which is presently widely used in the production of laser mirrors is a zinc sulfide (ZnS) and thorium fluoride (ThF $_4$) quarter-wave stack. This combination is attractive for several reasons. Perry has shown that scatter losses can be held to a quite low level through the use of appropriate coating techniques. Ennos has determined that ZnS - ThF $_4$ multilayers contain relatively little net stress; this is because the compressive stress of each ZnS layer almost exactly balances the tensile stress of each ThF $_4$ layer. The practical significance of this is that large numbers of alternating ZnS and ThF $_4$ layers can be deposited on a substrate without cracking (or crazing) of the coating occurring. In addition, both ZnS and ThF $_4$ are moderately durable, are transparent well into the infrared, and are very easy to work with. We now briefly consider each of these materials individually.

ZnS is one of the most widely used of all coating materials. It has a relatively high index of refraction of about 2.2 and is transparent over the

entire range from 0.38 microns to 25 microns. One of the reasons for its wide use is the paucity of other suitable high-index coating materials. Other reasons are its ease of handling and excellent behavior during deposition. Its only drawback is its moderate durability.

ThF $_4$ coatings are also mechanically and chemically very stable. The index of refraction is approximately 1.51, and thus ${\rm ThF}_4$ is used as the low index material in a multilayer stack. ThF $_4$ is transparent from 0.20 microns through 15 microns, although Heitmann and Ritter have noted a faint water absorption band at 3.0 microns. We have not been able to detect this absorption band from spectrophotometer traces which we have run on ${\rm ZnS}$ - ${\rm ThF}_4$ mirrors. Heitmann and Ritter also state that ${\rm ThF}_4$ coatings are obtained irrespective of whether ${\rm ThF}_4$ or ${\rm ThOF}_2$ is used as the starting material. ${\rm ThF}_4$ films are somewhat more durable than those of ${\rm ZnS}$.

2.1.2 ZnS - Cryolite

Another thin-film combination which has been widely used, especially for visible mirrors, is ZnS and cryolite. Neither of these materials is particularly hard, but both are easy to evaporate and both give high optical performance even when condensed on a cold substrate. Ennos 3 found that moderate stress build-up occurs in ZnS - cryolite multilayers. The buildup is about a factor of five greater than for ZnS - ThF $_4$ multilayers. One reason for trying this particular combination was that Steinberg, et al found that the use of soft coating materials in multilayers gave high damage thresholds.

ZnS has been discussed already, so we discuss only cryolite here. Cryolite has an index of refraction of 1.35 and is transparent from 0.20 microns to 14 microns. Like ZnS, cryolite sublimes, rather than melts, and can be deposited from a tantalum or molybdenum boat. The scatter properties of cryolite coatings have been studied by Perry in ZnS - cryolite multilayers, and have been found to be excellent.

2.1.3 Mirrors with Al_2O_3 Overcoatings

Because of the somewhat fragile nature of the above coatings, it was decided to try a single-layer overcoating of aluminum oxide (${\rm Al}_2{\rm O}_3$) for protection of some of the mirrors. A half-wave overcoating of ${\rm Al}_2{\rm O}_3$ was applied

to both ${\rm ZnS-ThF}_4$ and ${\rm ZnS-cryolite}$ mirrors of the types just described in Sections 2.1.1 and 2.1.2. Aluminum oxide has an index of about 1.59 and is transparent from 0.2 microns to about 7 microns. It forms an extremely durable coating and has long been used to protect letal mirrors 13 . It is likely that other materials such as ${\rm SiO}_2$ or ${\rm SiO}$ would also have proven satisfactory as overcoatings for oscillator mirrors. However Lambda Optics has previously had outstanding overcoating success with ${\rm Al}_2{\rm O}_3$ and it was therefore selected for this application.

2.1.4 Mirrors with Al_20_3 Undercoatings and Overcoatings

As will be described later, the ${\rm Al}_2{\rm O}_3$ overcoatings, in general, proved effective in providing protection to the oscillator mirrors. It was decided to therefore try ${\rm Al}_2{\rm O}_3$ undercoatings as well as overcoatings with ZnS - ThF $_4$ and ZnS - cryolite mirrors. It was hoped that the undercoating would provide substrate (lithium niobate) protection while the overcoating provided mirror protection. The undercoating and overcoating were each one-half wavelength thick.

2.1.5 Spectrum Systems Coatings

All of the coatings discussed thus far (except for the ${\rm Al}_2{\rm O}_3$ overcoating) are composed of low melting point materials. The rather stable optical properties of these materials enable one to control the optical thickness of individual layers with little difficulty. Thus the spectral response of coatings made with these materials is excellent, but the coatings themselves are not particularly durable. Numerous other materials exist which have much higher melting points and are much sturdier physically, but they are also considerably more difficult to deposit 14. They can be produced by employing electron-beam evaporation technology, rather than the conventional tungsten filament heating method. Many of these materials are oxides such as ${\rm Al}_2{\rm O}_3$, ${\rm SiO}_2$, ${\rm TiO}_2$, ${\rm ZrO}_2$, etc. which present special difficulties during electron-beam evaporation. These difficulties include:

a) Molecular binding energies of oxides are much smaller than the electron energies needed to evaporate the oxides. Thus during evaporation one tends to disassociate molecules and to produce absorbing films.

- b) The index of refraction of these materials tends to change during evaporation. This makes it difficult to control the optical thickness of the film, and hence the spectral reflectance of the coating. For some materials, the change in index can be as great as 50%.
- c) These hard materials usually tend to have more scatter centers, and hence result in lossier coatings.

In spite of these difficulties, we elected to try one lot of mirrors which consisted of very durable materials. These mirrors were purchased from Spectrum Systems, Inc. of Waltham, Massachusetts. All other mirrors used on this program were fabricated by Lambda Optics and Coating, Inc., the subcontractor. The dielectric layers used in the Spectrum Systems coatings are actually mixtures of materials, 15-17 rather than pure materials. They have found that better adhesion and durability are obtained with these mixtures than with pure materials. Spectrum Systems would not divulge the materials involved nor the ratios in which they were mixed, considering this information to be company proprietary.

2.2 MIRROR SUBSTRATES

The various coatings that were studied on this program were each deposited on both fused quartz and lithium niobate substrates. As explained in Section I, an external oscillator configuration requires that the parametric oscillator mirrors be deposited on fused quartz substrates; an internal oscillator configuration utilizes parametric oscillator mirrors that are deposited directly on the nonlinear crystal (lithium niobate in this case). It was felt that the scatter, spectral transmittance, and damage properties of the coatings might depend upon the substrate employed, and thus we elected to use both fused quartz and lithium niobate substrates on this program. Details of the substrates which were used are given below.

2.2.1 Fused Quartz Mirror Substrates

Lambda Optics and Coating, Inc. fabricated fused quartz mirror substrates for this program. These substrates, when appropriately coated, were used in making spectral transmittance and coating damage measurements. The substrates were fabricated from infrasil, which transmits out to a wavelength of about 3.5 microns. The substrates were 15 mm in diameter, 11 mm thick

(a standard size for laser mirrors), and were flat. The surfaces were parallel to within 30 seconds or better, flat to within 1/10 wavelength, and of 0-0 surface quality. An uncoated fused quartz substrate is shown in Fig. 3.

2.2.2 Lithium Niobate Disks

The second secon

Lithium niobate disks were fabricated by Sylvania and used as substrates on this program. One surface of each disk was coated and the disks used in spectral transmittance and coating damage tests. A c-axis stoichiometric lithium niobate boule of acoustic-grade quality was purchased from Crystal Technology, Inc., of Mountain View, California. This boule was cut into disks 14 mm in diameter and 2.3 mm thick. The surface flatness was approximately 1 wavelength, and the surface parallelism 30 seconds or better. The c-axis (optic axis) of the lithium niobate was perpendicular to the pol shed faces. One of these disks is shown in Fig. 3.

2.2.3 Lithium Niobate Oscillator Crystals

Lithium niobate crystals which are suitable for use in an optical parametric oscillator were fabricated by Sylvania for this program. Coatings were deposited on both faces of each crystal. The coated crystals were used to measure coating scatter, damage thresholds (qualitatively), and parametric oscillator performance. A stoichiometric a-axis lithium niobate boule of "linobate" (highest) quality was purchased from Crystal Technology, Inc. This boule was cut into crystals approximately 5 mm long and 8.4 by 7.1 mm in cross section. Crystals were oriented with the c-axis at an angle of $48^{\circ}30'$ with respect to the end faces; this orientation resulted in phasematching for parametric oscillation at a temperature of about 100° C. The crystal faces were polished flat to within 1/8 wavelength and parallel to within 5 seconds. One of these oscillator crystals is pictured in Fig. 3.

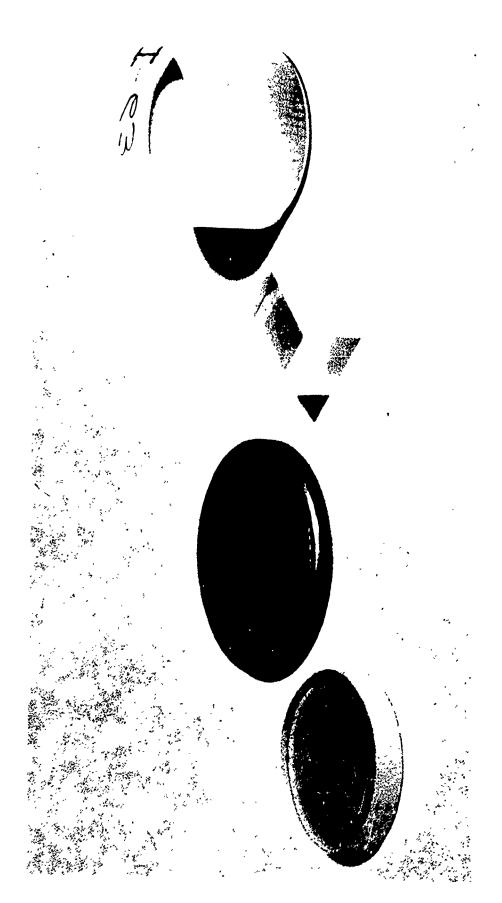


Figure 3 Lithium niobate and fused quartz substrates used on this program

2.3 MIRROR DESIGNS

Mirrors with several different spectral transmittances were designed and fabricated on this program. In this section, we discuss the designs which were employed. In order to clarify our list of mirror types, we have schematically shown external and internal oscillators in Figs. 4a and 4b, respectively.

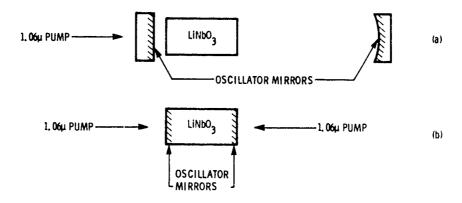


Figure 4 Parametric oscillator resonators for (a) external oscillator and (b) internal oscillator.

2.3.1 Mirror Coating Type #1

Coating type #1 is a relatively simple coating to design and fabricate, but one which is very important. This coating is a conventional high-reflectivity coating centered at the signal wavelength of the parametric oscillator. This coming would be used on both ends of the internal and external oscillators of Figs. 4a and 4b to produce singly-resonant operation. The coating is highly reflecting at the signal wavelength, but is transmitting at the idler wavelength. In addition, it is desirable to have low reflectivity at the pump wavelength of 1.08 microns. For the external oscillator of Fig. 4a, this allows most of the pump to enter the lithium niobate crystal. The 1.08 micron reflectivity is important for a different reason for the internal oscillator of Fig. 4b. The coated lithium niobate crystal with its flat end faces acts as an etalon inside the Nd:YA103 laser. If the 1.08 micron reflectivity is too large, it will be very difficult to make the laser operate.

The type #1 coating will also be useful in a second situation. If the high-reflectivity region is centered at 2.16 microns, then this coating will be appropriate for use on one end of the crystal in a doubly-resonant oscillator operating near degeneracy. Because the high-reflectivity region would cover from about 1.95 to 2.35 microns, the oscillator output could be tuned over the same range. The early coatings fabricated on this program were centered at 2.1 microns and were intended for use in a doubly-resonant oscillator. Later HR coatings were centered at 1.6 microns and were used in a singly-resonant 3 micron oscillator.

The design used for HR coatings is shown in Fig. 5 for ZnS - ThF $_4$ mirrors. The initial coating layer is ThF $_4$ and is 1/12 wavelength thick (at the signal wavelength). This is followed by 21 alternating quarter-wave layers of ZnS and ThF $_4$. ThF $_4$ is used as the initial layer because of its superior adhesion to the substrate; ZnS is used as the final layer because of its apparent better durability as an outer layer. The initial ThF $_4$ layer could have been $\lambda/4$ thick instead of $\lambda'12$ thick. If fused quartz is the substrate, the $\lambda/12$ layer is used since the indices of ThF $_4$ and fused quartz are nearly equal. If lithium niobate is the substrate, a $\lambda/4$ thickness should be used for the initial layer.

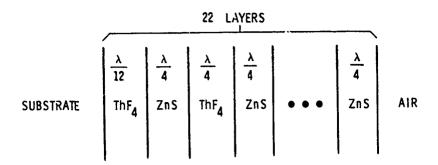


Figure 5 Design used for ZnS - ThF_{L} highly reflecting mirrors

For HR mirrors composed of ZnS and cryolite, a total of 21 alternating layers was used with the initial layer being a $\lambda/4$ layer of ZnS. In this case, both the first and last layers were ZnS.

2.3.2 Mirror Coating Type #2

Coating type #2 is similar to #1 but contains fewer layers. This coating is designed to transmit a few percent at the signal (or idler) wavelength, and to be highly transmitting (85% or more) at the pump wavelength. This coating was used primarily as the transmitting coating for the doubly-resonant 2.16 micron oscillator. The composition of this coating is shown in Fig. 6. An initial $\lambda/12$ layer of ThF₄ is followed by 9 alternating $\lambda/4$ layers of ZnS and ThF₄. For the ZnS - cryolite mirrors, a 9 layer coating starting with a $\lambda/4$ layer of ZnS was used.

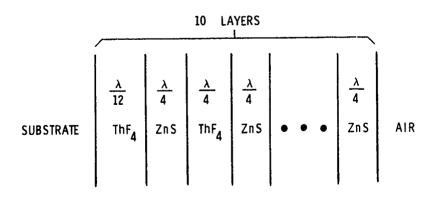


Figure 6 Design used for ZnS - ThF_{L} partially transmitting mirrors

The coatings of Figs. 5 and 6 are standard multilayer designs and reflect the fact that mirror reflectivity increases as the number of layers used increases. We have performed calculations of midband reflectance as a function of the number of layers used; this calculation was carried out for ZnS and ThF₄ alternating layers on both lithium niobate and fused quartz. In this calculation, we assume that the first layer is a $\lambda/4$ layer (rather than a $\lambda/12$ layer) of ThF₄. The indices of refraction which we used are fused quartz (1.437), lithium niobate (2.195), ZnS (2.20), and ThF₄ (1.50). The results of this calculation are shown in Table 1.

There are two important things to be noted from the data of Table 1. First for a given value of n, the reflectivity can be substantially different for fused quartz and lithium niobate substrates. As an example, for n=7 reflectivities are 53% and 66% for quartz and niobate substrates, respectively. Thus one should not design lithium niobate coatings using fused quartz mirror design data. Secondly, from the viewpoint of minimizing the number of coatings required to achieve a particular reflectance, it is advantageous to have the top layer be ZnS. This is demonstrated by the fact that the reflectance is 99.7% for both n=18 and n=21.

2.3.3 Mirror Coating Type #3

Coating type #3 is designed to be highly reflecting at the oscillator signal wavelength, while having slight transmission at the idler wavelength. The mirror is designed to be used on one or both ends of the crystal in either an internal or external doubly-resonant, nondegenerate parametric oscillator. This mirror is designed by beginning with an HR (or slightly transmitting) stack at the idler wavelength, and placing on top of it an HR stack at the signal wavelength. The design which was used for $\lambda_{\rm idler} = 3.6$ microns and $\lambda_{\rm signal} = 1.56$ microns is shown in Fig. 7. This mirror was HR at 1.56 microns and transmitted about 5% at 3.6 microns. The difficulties involved with fabricating mirrors for a doubly-resonant oscillator are illustrated by the design of Fig. 7. These difficulties are primarily involved with the large amount of material which must be deposited on the substrate. The design of Fig. 7 consists of 32 layers, a large number by coating standards. Furthermore, the last 21 of these layers are almost 1 micron thick apiece. With

Table I

Mirror reflectivity as a function of the number of coating layers used. Odd-numbered layers are ThF₄ and even-numbered layers are ZnS.

Number of	MIRROR REFLECTIVITY		
Layers	(ρ'	Tit cur am	
n	Quartz Substrate	Niobate Substrate	
1	.0486222	.0001531	
2	.2612636	.4230889	
3	.0248013	.1256932	
4	.5454437	.6736115	
5	.2443799	.4061487	
6	.7557030	.8325963	
7	.5302108	.6614031	
8	.8780530	.9184006	
9	.7460007	.8256031	
10	.9413506	.9612062	
11	.8728153	.9148127	
12	.9722957	.9817752	
13	.9387382	.9594594	
14	.9870243	.9914861	
15	.9710407	.9809454	
16	.9939468	.9960330	
17	.9864318	.9910964	
18	.9971815	.9981539	
19	.9936694	.9958510	
20	.9986887	.9991414	
21	.9970521	.9980691	
22	.9993902	.9996007	
23	.9986285	.9991019	
24	.9997165	.9998144	
25	.9993622	.9995824	
26	.9998682	.9999137	
27	.9997034	.9998058	
28	.9999387	.99,9599	
29	.9998621	.9999097	
30	.9999715	.9999813	

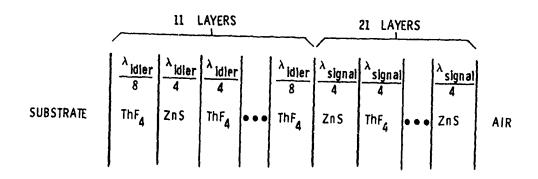


Figure 7 Design used for doubly-resonant $ZnS-ThF_4$ mirrors

this large amount of coating material, coating scatter and stress are the problems which must be overcome (and have been on this program) in order to obtain useful optical parametric oscillator coatings.

Section III

COATING AND TESTING PROCEDURES

3.1 COATING TECHNIQUES AND APPARATUS

The majority of the coating work on this program was performed by Lambda Optics and Coating, Inc., of Berkeley Heights, New Jersey. Lambda is a commercial supplier of various types of optical coatings and was a subcontractor on this program.

Lambda has four Consolidated Vacuum Corp. LCV-18 vacuum evaporators. Each of these has a 6" diameter oil diffusion pump, chevron-type cooling baffles, and an 18 inch diameter bell jar plus all associated electrical, vacuum, and optical controls. Three of the four evaporators are used for depositing relatively volatile materials by means of resistive heating. One such evaporator is pictured in Fig. 8. The resistive heating technique was used to deposit the ZnS, ThF_{h} , and cryolite films used on this program.

The fourth evaporator used on this program is shown in Fig. 9. This evaporator uses a four-pocket, 270 degree Airco Temescal electron gun driven by a 10 kW power supply to volatilize and deposit high-temperature materials. The ${\rm Al}_2{}^0{}_3$ films were deposited using this evaporation technique. Both resistive-heating evaporation and electron-beam evaporation are discussed by Macleod ${}^1{}_8$.

Each Lambda evaporator has a thin-film thickness monitor which utilizes a He-Ne laser operating at $6328 \mbox{\AA}$. A complete description of this monitoring system has been given by Perry 5 .

3.2 SCATTER EVALUATION

Two tests were used on this program in order to evaluate scatter in the mirror coatings. The first of these is by visual observation using a microscope with camera attachmenc. A Leitz Ortholux large research polarizing microscope was used and is pictured in Fig. 10. This microscope is fitted with an FS binocular tube, which is a combination of a binocular viewing tube and photographic tube. The Leitz is fitted for dark-field microscopy and

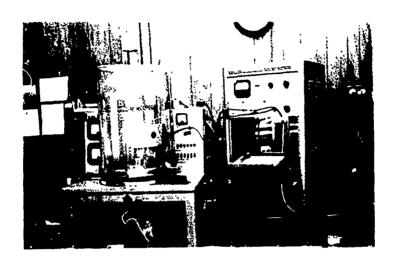


Figure 8 Evaporator used for low-temperature materials such as ZnS, ${\rm ThF}_4$, and cryolite.

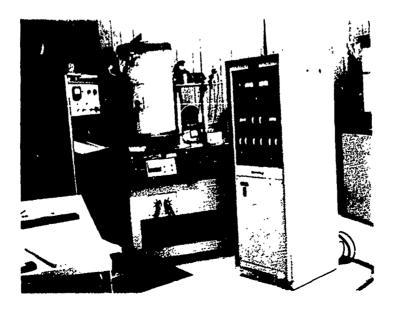


Figure 9 Evaporator with electron-gun source for evaporating hightemperature materials

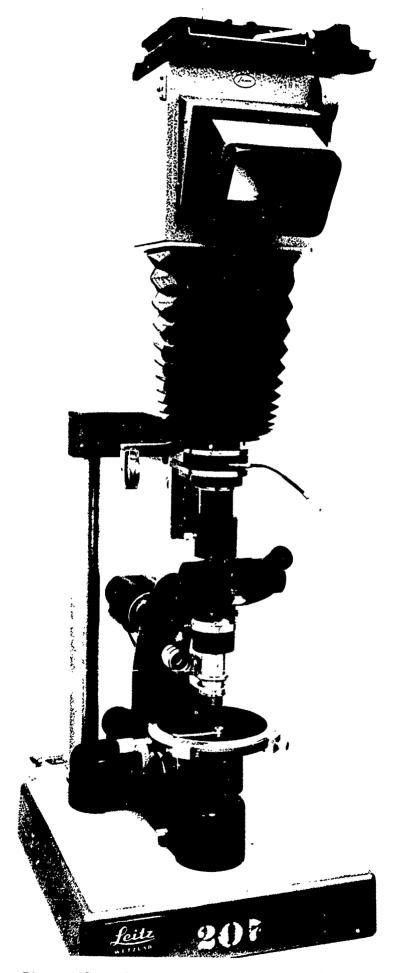


Figure 10 Leitz Ortholux polarizing microscope

accommodates a 4 x 5 inch bellows with a Polaroid-Land camera attachment. Three objective lenses were available which produced magnifications of 17, 28, and 78. The middle value was used for the majority of our work. Approximately two hundred photographs of coatings were taken during this program.

A second test was also employed to measure mirror scatter losses in addition to the photographic technique described above. We have used this test successfully the past 2 years on our oscillator programs as well as on this program. The setup for the test is shown in Fig. 11 and the procedure is as follows. The output power from a CW Nd:YA10, laser is measured with nothing in the cavity. One of the coated substrates (shown dotted in Fig. 11) is then inserted in the laser cavity and adjusted so the laser's output is maximized. This coated substrate will act as an etalon inside the laser because its faces are flat and very parallel. This second output power will be less than the first because of the insertion loss of the substrate and because of scatter and absorption losses of the coating(s). The insertion loss of the substrate alone will have been previously determined by measuring the laser output power with the uncoated substrate in the laser, and thus it will be possible to determine losses due to scatter from the coatings alone. The advantages of this technique include (1) laser output powers typically vary rather widely for fairly small changes in insertion loss, and (2) the configuration of this test is identical with the actual operating conditions of an internal optical parametric oscillator, and thus this test gives directly useful results. Any of the three coated substrates mentioned earlier in Section 2.2 could have been used in these tests. However, we felt it would be most useful to perform this test using the coated oscillator crystals as the substrate. The crystals have two coatings and give the two-coating losses from this test. We note that uncoated fused quartz substrates consistently introduce virtually no loss at all inside the laser, while the loss from uncoated lithium niobate crystals varies from crystal to crystal and is considerably higher.

3.3 SPECTRAL TRANSMITTANCE EVALUATION

The second secon

Tests were performed on each type of coating to measure its spectral transmittance and to determine whether it matches the desired transmittance. These tests were performed using a Perkin-Elmer model NIR 137G Infracord

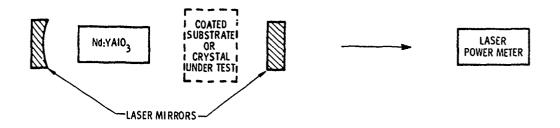


Figure 11 Technique for determining scatter losses from coated crystals and substrates.

spectrophotometer (shown in Fig. 12). This instrument is a double-beam grating spectrophotometer that covers the wavelength range from 0.9 micron to 7.65 microns. The 137G has an accuracy of \pm 0.004 microns in range #1 (0.9 to 2.55 microns) and an accuracy of \pm 0.012 microns in range #2 (2.45 to 7.65 microns). Reproducibility is 0.003 microns or better in range #1 and 0.008 microns or better in range #2. The transmission accuracy of the instrument is 1% or better.

3.4 DAMAGE THRESHOLD EVALUATION

Investigation of coating damage and substrate damage levels were carried out in two different ways. In the first, the coated substrate is mounted in front of the Nd:YAlO₃ laser. The laser output is focused onto the coating and damage measurements carried out. Coated lithium niobate disks and coated fused quartz substrates were used in these tests. In the second type of test, a coated oscillator crystal is placed inside the pump laser and an internal oscillator operated. Following operation of the oscillator, the crystal is removed and inspected for coating and substrate damage. There are at least two important differences between the two test procedures: (1) The first test uses a TEM oo laser beam whereas the second test employs a high-order-mode laser; (2) In the first test, only the 1.08 micron pump is present; in the second test, signal, idler, and pump wavelengths are all present.

We now consider the first test procedure in more detail. The setup used in this first procedure is shown in Fig. 13. The laser used in these experiments is a $\mathrm{Nd:YAlO}_3$ laser which is pumped by two tungsten-iodide lamps. The laser is continuously pumped and repetitively Q-switched by means of a CRL model 460 acousto-optic Q-switch. Tests were performed both with a TEM $_{\mathrm{OO}}$

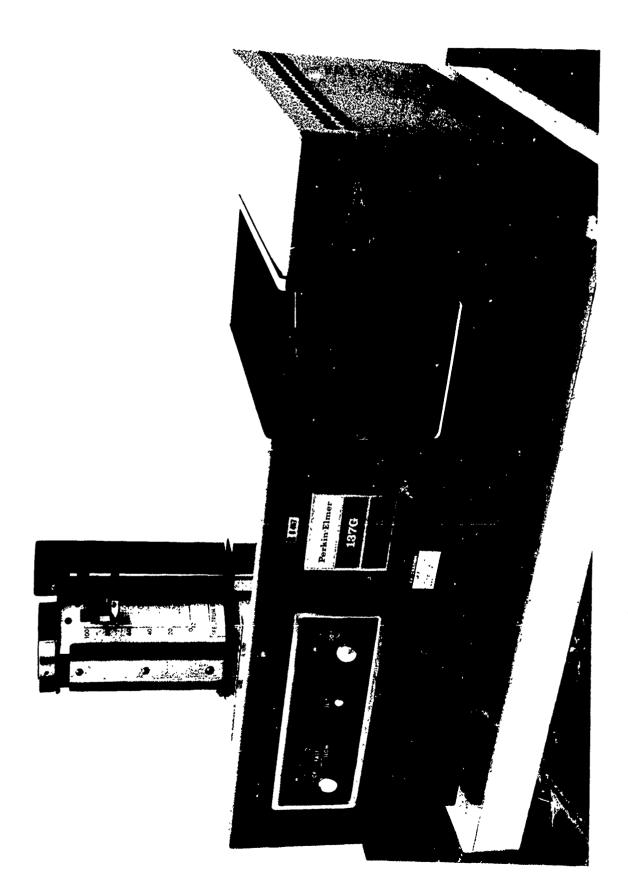


Figure 12 Perkin-Elmer Model 137G Spectrophotometer

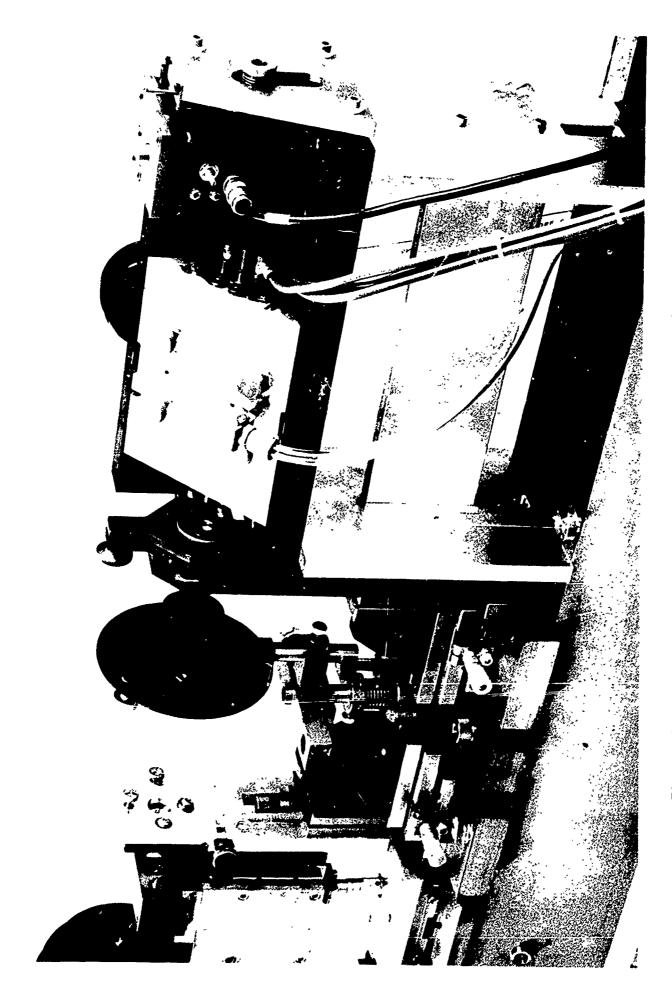


Figure 13 Test setup used for coating-damage threshold measurements

mode output and with a high-order mode output. The available 1.08 micron Q-switched average output power for these tests was 0.5 watts and 3.5 watts for fundamental mode and high-order mode operation, respectively. A repetition rate of 4 kHz was used in all tests; pulse lengths were 140 ns and 350 ns for fundamental and high-order mode operation.

The laser output was focused onto the specimen under test by a 1.3 cm The coating under test was on the front surface of the substrate in all cases. A polarizer preceding the lens was employed as a continuously variable attenuator. A specimen holder in which four samples could be mounted side by side was located at the focus of the lens. This specimen holder is shown in more detail in Fig. 14. The specimen holder could be translated vertically and horizontally by means of micrometer adjustments. During a damage test, the specimen holder was translated back and forth horizontally three times with the laser power fixed at a particular level. The horizontal translation distance was 0.100 inches for each test. In this way, the laser beam impinges upon numerous areas of the test coating, rather than on a single location. As a coating first begins to damage, there will be only one or two damage spots across this line. As the power levels increase above the damage threshold for the coating, the number of damage spots occurring on the 0.100 inch line also increases. This type of test is compatible with the probabilistic nature of laser-induced damage 19. At high power densities, the number of damage spots across the 0.100 inch line increases, reflecting the increased probability of damage occurring. After each test, the specimen holder was removed and the coatings examined under a microscope for damage. The coatings were photographed (under magnification) before and after each test in order to facilitate the search for damage.

The incident 1.08 micron power density at the test coating was calculated from the known incident average power, pulse length, repetition rate, and beam size at the lens focus. The beam size at the focus was determined by two different methods: (1) The beam diameter entering the lens was measured and the focused spot size then calculated using standard formulas; and (2) the spot size at the focus was measured directly using a very small aperture. These two methods gave results which agreed to within approximately

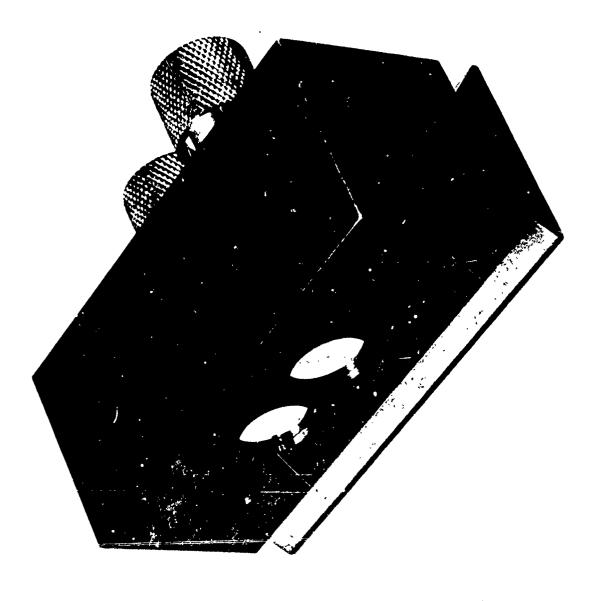


Figure 14 Specimen holder for coating damage tests.

10%. The definition of beam diameter used here is the familiar $1/e^2$ power points of the TEM mode. The power densities which we quote in Section VI are the power densities at the <u>center</u> of the Gaussian mode. These are obtained by first using the $1/e^2$ area to calculate an average power density, and then multiplying this by two to allow for the fact that the center power density of a Gaussian beam is twice the average power density.

The maximum 1.08 micron TEM_{00} power densities which were attainable with our setup were about 200 MW/cm². The Rayleigh range for the beam in our setup was only 0.034 inches. Thus it was necessary to take special precautions to ensure that the coating under test was actually located at the beam focus. A small test aperture was inserted into one of the holes of the mirror fixture of Fig. 14. This test aperture butted against the same retaining lip that the substrates did when they were in the holder. The test aperture (in the holder) was used to locate the beam focus. The test aperture was then removed and a coated substrate inserted in the same hole. A series of damage tests were run on the coated substrate, with longitudinal translations of 0.005 inches being made between tests. By noting the longitudinal position at which the severest damage occurred, the correct holder position was determined to within 0.005 inches. Once this longitudinal position had been established, the test fixture could be removed and replaced (as when photographing coating damage) without altering this position. We estimate that the power densities quoted in this report are accurate to within + 20%.

Section IV

SCATTER CHARACTERISTICS OF FABRICATED MIRRORS

As noted in Section 1, it is crucial that parametric oscillator mirrors contain very little scatter. One of the reasons that Lambda Optics and Coating, Inc. was selected to be the subcontractor on this program is that we had previously determined that Lambda coatings have very little scatter. Perry has elaborated on the techniques which he has developed and used, first at Bell Laboratories and now at Lambda, to obtain low-scatter coatings. These and subsequent techniques employed by Lambda for this program are discussed below in Section 4.1.

4.1 TECHNIQUES USED TO OBTAIN LOW-SCATTER COATINGS

The scatter properties of multi-layer coatings are greatly dependent upon (1) proper cleaning and preparation of the substrates involved, (2) careful selection of the material to be deposited, and (3) the use of proper deposition techniques. We will consider substrate preparation first. The polished surface should, of course, be free of pits and scratches. Lambda Optics uses a final cleaning procedure (just prior to coating) which consists of washing the blank with a solution of Alconox and water applied with a soft camel's hair brush. This solution is rinsed off with tap water, and the blank then is rinsed thoroughly with distilled deionized water. The surface to be coated then is blown dry with nitrogen. If the surface is clean, the water will disappear rapidly with no droplets remaining. Such cleaning eliminates evaporation of the water from the surface which, if allowed to occur, will usually produce water marks that are difficult to detect until after coating. The rest of the mirror blank then is dried with nitrogen, making sure that no water reappears on the surface to be coated. The surface to be coated then is inspected by shining a bright light (microscope lamp) through the blank and observing the amount of scattered light from the surface. Poor polish and grinding defects may be detected in this manner.

The above cleaning procedure is performed in close proximity to a dust-free portable hood. In order to minimize further the possibility of dust particles accumulating on the clean surfaces, the hood containing the clean

substrates is located next to the coating station. The mirror blanks are placed into the coating adapters within 5 or 10 min after the cleaning procedure. The back surfaces are kept free of unlanted vapor deposition by being covered during the evaporation. Initial roughing of the bell jar is done slowly to avoid raising a dust of small particles remaining from previous evaporations.

One step in the coating procedure which is rather widely recommended in the literature is that a glow discharge be used to clean the substrate just prior to deposition. Lambda has found that the use of glow-discharge cleaning results in greater coating scatter than if glow-discharge cleaning is not used. This scatter is possibly due to the glow discharge sputtering particles which have previously accumulated on the coater walls onto the clean substrate. A glow discharge was not used in any of the work done on this program.

As discussed later in Section 4.2, ThF_4 presents more of a problem in achieving low-scatter coatings than do other materials. The number of suppliers of this type of coating material is limited and their materials differ greatly. Using the radiant-heat type of evaporation, it is advisable to make test runs with each lot of material received, and to select that which shows the least scattering effect. The absence of scattering (and absorption) losses in a mirror coating can be determined very nicely by using these mirrors with a helium neon laser and obtain lasing action at 5433\AA , the shortest wavelength to lase in helium neon, as well as by visual observation by microscope.

The form of the ${\rm ThF}_4$ prior to evaporation is also very important in determining coating scatter. Lambda Optics found that minimum scatter centers resulted when the ${\rm ThF}_4$ was evaporated just below its wetting temperature. Further improvement in mirror quality was obtained when the ${\rm ThF}_4$ powder was sifted through a U.S. standard series 200 sieve. The most pronounced decrease in scatter centers occurred when the ${\rm ThF}_4$ was evaporated from chunks as received from the supplier. A possible reason for this may be that in the powder state trapped gases can form pockets which are liberated suddenly when the material is heated, releasing small showers of the surface material. The temperature required to evaporate the ${\rm ThF}_4$ in the chunk state appeared to be more nearly constant for a given number of layers than when the powdered state was used.

4.2 RESULTS OF SCATTER TESTS

teles Consideration and the second second of the second of

As indicated in Section 2.1, several different types of coating materials were tried on this program. Lambda Optics fabricated mirrors which were composed of (a) ${\rm ZnS-ThF_4}$; (b) ${\rm ZnS-ThF_4}$ overcoated with ${\rm Al_2O_3}$; (c) ${\rm ZnS-cryolite}$; (d) ${\rm ZnS-cryolite}$ overcoated with ${\rm Al_2O_3}$; and (e) ${\rm ZnS-ThF_4}$ undercoated and overcoated with ${\rm Al_2O_3}$. In addition, Spectrum Systems fabricated mirrors composed of layers which were mixtures of materials. Photographs were taken of each type of mirror using the Leitz microscope of Fig. 10. The results are given in Fig. 15. All coatings shown in Fig. 15 were HR at 2.16 microns and were deposited on fused quartz substrates.

The following conclusions can be drawn from the data of Fig. 15.

- (1) The ZnS-ThF₄ coatingsof Fig. 15a have very little scatter. These coatings are excellent from a scatter viewpoint. For comparison we show photos of similar mirrors from Laser Optics and Valpey Corp. in Figs. 15g and 15h, respectively. The Lambda mirrors are clearly superior from a scatter viewpoint.
- (2) The ZnS-cryolite coating of Fig. 15c has even less scatter than the ZnS-ThF $_{\!\Delta}$ coating of Fig. 15a.
- (3) An ${\rm Al}_2{}^0{}_3$ overcoating contributes virtually no additional scatter to the mirror. This can be seen by comparing Fig. 15b to 15a and Fig. 15d to 15c.
- (4) The scatter present in the coating of Fig. 15e is about double that of Fig. 15a. We believe that this is not due to the ${\rm Al}_2{\rm O}_3$ undercoating and overcoating, but rather to the ZnS-ThF $_4$ layers. The ZnS-ThF $_4$ layers of Fig. 15e were not deposited at the same time as those of Figs. 15a and 15b.
- (5) The hard coatings from Spectrum Systems shown in Fig. 15f have somewhat more scatter than the Lambda coatings, but this scatter level is still acceptable. Unfortunately however, Spectrum Systems coatings on lithium niobate have much more scatter than Lambda coatings on niobate. This phenomenon is discussed further in Section 4.3.

Coating scatter was also evaluated using the insertion-loss test of Fig. 11. These tests were run using oscillator crystals with 2.16 micron coatings on both ends. The results are shown in Table 2. It can be seen that the presence of two Lambda coatings inside the pump laser caused only

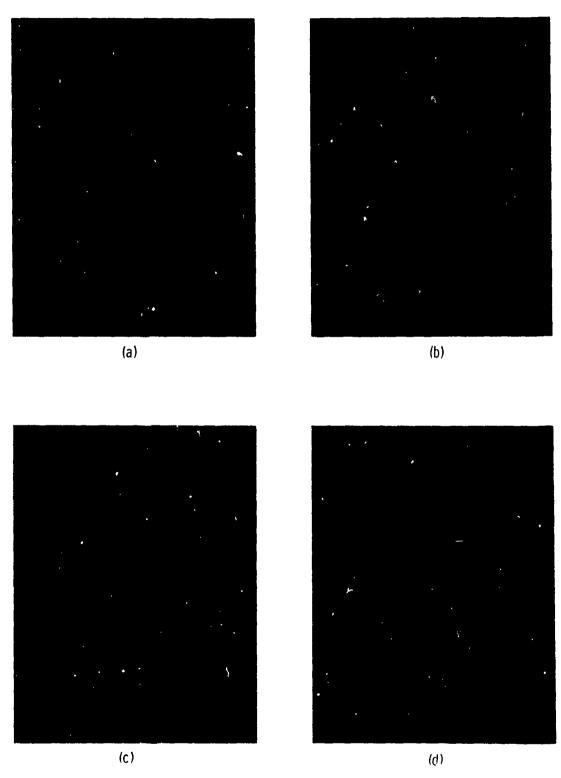


Figure 15 Scatter Characteristics (magnification 20) of 2 micron HR mirrors fabricated by (a) Lambda (ZnS-ThF₄), (b) Lambda (ZnS-ThF₄ overcoated), (c) Lambda (ZnS-cryolite), (d) Lambda (ZnS-cryolite overcoated), (e) ZnS-ThF₄ undercoated and overcoated, (f) Spectrum Systems, (g) Laser Optics, and (h) Valpey. All coatings are on fused quartz substrates.

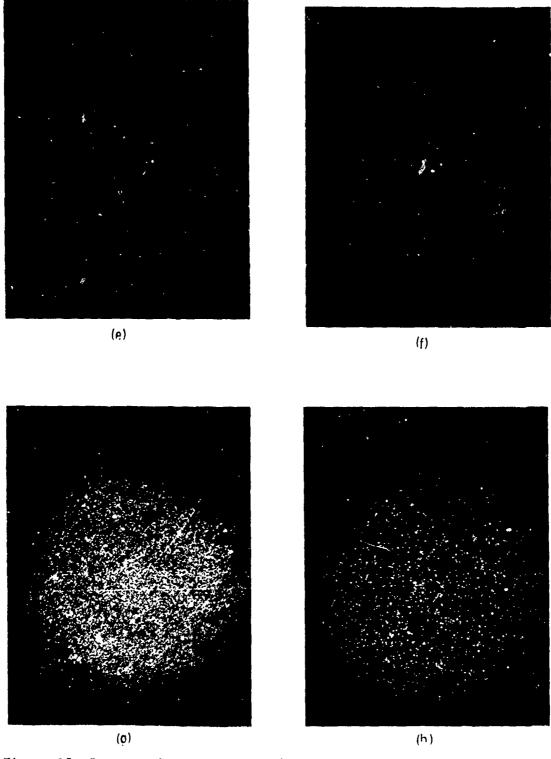


Figure 15 Scatter Characteristics (magnification 20) of 2 micron (Continued) HR mirrors fabricated by (a) Lambda (ZnS-ThF₄), (b) Lambda (ZnS-ThF₄ overcoated), (c) Lambda (ZnS-cryolite), (d) Lambda (ZnS-cryolite overcoated), (e) ZnS-ThF₄ undercoated and overcoated, (f) Spectrum Systems, (g) Laser Optics, and (h) Valpey. All coatings are on fused quartz substrates.

relatively small power decreases; typically the power dropped from about 5.5 watts to 4.4 watts due to the coatings. This decrease is quite acceptable for internal oscillator operation. The Spectrum Systems coatings faired very poorly on this test, but this cannot be blamed entirely on scatter. As we will see in Section 5, the 1.08 micron transmission of the Spectrum System coatings was quite low and this, rather than scatter, was probably primarily responsible for these results.

As already noted, the 2 micron HR ZnS-ThF $_4$ coatings by Lambda had excellent scatter properties. These coatings used the design given in Fig. 5. The more complicated mirror design of Fig. 7 has more coating layers, and hence might be expected to show greater scarter. Figure 16 shows a photograph (28 times magnification) of a Lambda mirror employing the design of Fig. 7. It can be seen by comparing Figs. 16 and 15a that the additional layers have caused only a slight increase in scatter. Thus acceptable scatter levels are obtained for all mirror designs needed when Lambda ZnS-ThF $_4$ coatings are used.

There is occasionally some variation in scatter from lot to lot of Lambda coatings. The photos of Figs. 15a-15d and 16 are typical of the best results obtained; in other instances such as Fig. 15e, similar coatings have



Figure 16 Scatter characteristics (magnification 28) of Lambda 3.5 micron doubly-resonant ZnS-ThF₄ mirror.

Table II Insertion loss tests on coated lithium niobate crystals

Supplier of Coating	Coating Materials	Laser Power without Crystal	Laser Power w Uncoated Crystal	Laser Power w Coated Crystal
Lambda	${ m ZnS-ThF}_4$	8.0 warts	5.2 watts	4.1 watts
Lambda	$\mathrm{ZnS-ThF}_4$ Al $_2{}^0{}_3$ overcoat	8.0	5.8	4.3
Lambda	ZnS-cryolite	8.0	5.4	4.3
Lamb da	ZnS-cryolite $\mathrm{Al}_2{}^0{}_3$ overcoat	8.0	5.4	l
Lamb da	$\mathrm{ZnS-ThF}_{4}$ Al $_{2}^{0}$ undercoat and overcoat	8.0	5.4	4.4
Spectrum Systems		8.0	4.7	0.1

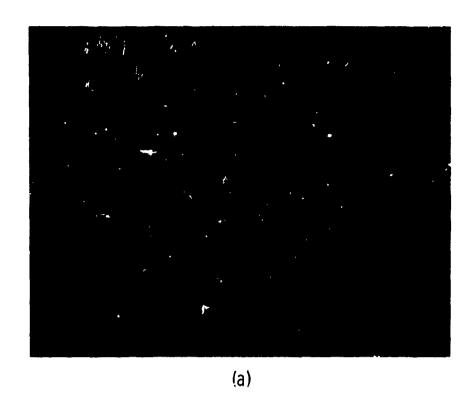
had up to twice the number of scatter centers. These higher scatter levels have not resulted in significantly greater values of insertion loss, however, and hence they are still acceptable. They do point up the fact that the sources of coating scatter are not completely understood. It appears that scatter centers are due almost entirely to the inclusion of foreign particles of dust or other contaminants in the coating. The dust can arise from a number of sources such as improperly cleaned substrates, material on the inside of the coater from previous runs, and the coating materials themselves.

A test was performed in an attempt to shed some light on the source(s) of scatter in ${\rm ZnS-ThF}_4$ coatings. A thick layer of ${\rm ZnS}$ was deposited on one quartz substrate and a thick layer of ${\rm ThF}_4$ on a second substrate. (Both of these layers were approximately 20 quarterwaves thick at 2.16 microns.) These coatings were then examined for scatter using the Leitz microscope. The results are shown in Fig. 17. Both coatings had relatively little scatter, but the ${\rm ThF}_4$ coating contained about twice as many scatter centers as the ${\rm ZnS}$ coating. If accumulated material from the inside of the coating chamber was the sole source of scatter, we would expect the scatter to be the same for both coatings. It thus appears that particles from ${\rm ZnS}$ and ${\rm ThF}_4$ account for at least part of the scatter present, with ${\rm ThF}_4$ providing more scatter particles than ${\rm ZnS}$. When Perry performed thick film scatter comparisons on ${\rm ZnS}$ and ${\rm ThF}_4$ in 1965, he found that ${\rm ThF}_4$ was the source of almost all the scatter centers. Since that time, however, he has found ways of greatly reducing the ${\rm ThF}_4$ contribution until it now only slightly exceeds the ${\rm ZnS}$ contribution.

It appears that cryolite contributes even fewer scatter centers than ${
m ThF}_4$. Evidence for this is provided by Figs. 15c and 15a which show that a ${
m ZnS-cryolite}$ coating has less scatter than a ${
m ZnS-ThF}_4$ coating.

4.3 COATING SCATTER CAUSED BY THE PYROELECTRIC EFFECT

The coating scatter data of Section 4.2 was for coatings deposited on fused quartz substrates. One would expect that the scatter properties of coatings on lithium niobate substrates would be similar. This has not been the case, however. During the past several years, we have consistently found that when lithium niobate and fused quartz substrates were coated at the same time, the coating scatter was much greater in the lithium niobate coating.



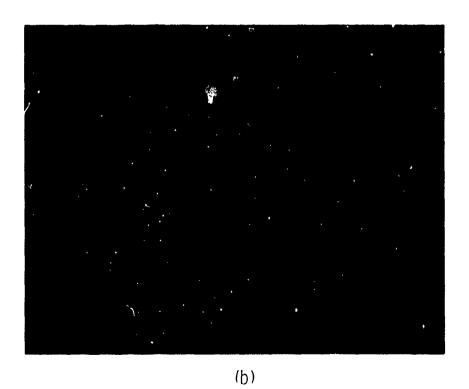
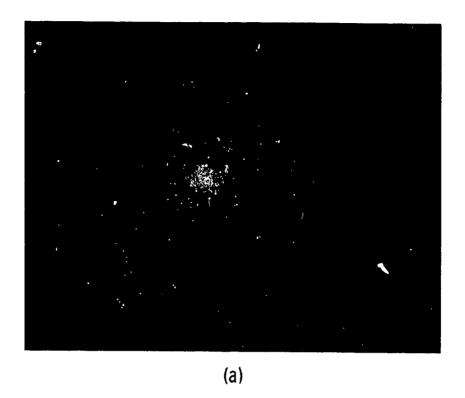


Figure 17 Thick layer of (a) ZnS and (b) ThF₄ on fused quartz substrates. Both layers are about 10 microns thick.

Examples of this are given in Figs. 18 and 19. Figure 18 shows doubly-resonant ZnS-ThF₄ coatings of the design of Fig. 7 deposited on (a) fused quartz and (b) lithium niobate. These two substrates were coated at the same time mounted in the same holder. Figure 19 shows doubly-resonant 2.16 micron hard coatings of the design of Fig. 5 deposited on (a) fused quartz and (b) lithium niobate. These two coatings were also deposited at the same time with the two substrates adjacent to each other. The coatings of Fig. 18 are by Lambda; the coatings of Fig. 19 are by Spectrum Systems. The Fig. 18 coatings are composed of ZnS-ThF₄; the Fig. 19 coatings are composed of hard, refractory materials. Yet this effect is seen in both these cases and we have observed it in numerous other cases. We have a theory concerning the cause of this effect which will now be given.

We propose that the pyroelectric effect in LiNbO₃ is responsible for the increased scatter evident in coatings deposited on its surfaces. Pyroelectric crystals have the property of developing an electric polarization when their temperature is changed. For lithium niobate, the induced polarization is along the crystalline z axis. With this induced polarization, the crystal is effectively electrically charged and will attract other charged particles (such as dust particles in a coating chamber) to its surface. In a coating chamber, the lithium niobate crystal (and all other substrates also) is heated either intentionally or by accident (such as by heat radiated from the resistive-heating coil located at the source). As we will show, even a temperature rise of 10°C or so is sufficient to induce a substantial polarization in the crystal.

We have performed tests to measure the induced polarization as a function of temperature on two different lithium niobate crystals. The first crystal was oriented with its z axis at an angle of 46° to its end faces as in Fig. 1. This crystal was a typical oscillator crystal and was uncoated. Since the z axis has a component perpendicular to the crystal end faces, we expect to see induced charge on the crystal ends. The second crystal was oriented with its z axis parallel to its end faces. This crystal orientation is not useful for our oscillator work, but is widely used in second-harmonic generation work. For the second crystal, the z axis has no component perpendicular to its end faces, and thus we expect no induced charge. During our tests, the crystals were mounted in (a) a copper (parametric oscillator) oven and (b) an insulating oven. These ovens made good contact with the sides of the



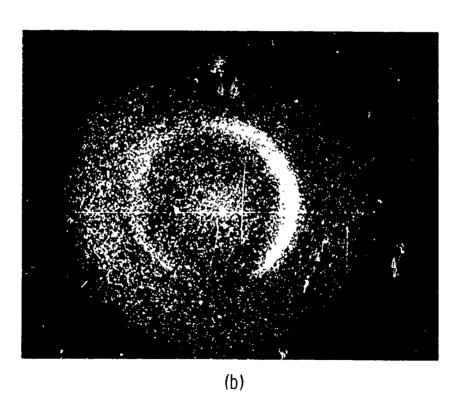
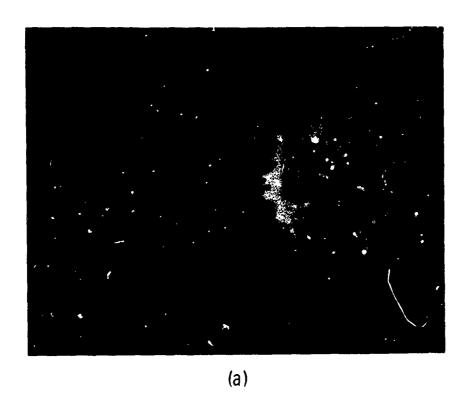


Figure 18 Scatter present in ZnS-ThF, coatings deposited on (a) fused quartz substrate, and (b) lithium niobate substrate.



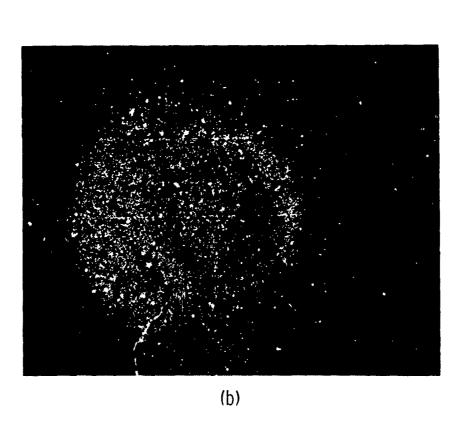


Figure 19 Scatter present in Spectrum Systems coatings deposited on (a) fused quartz substrate, and (b) lithium niobate substrate.

crystals but did not touch the crystal ends. An electro-static probe was placed about 0.035" from one face of the crystal under test and was connected to an electrometer. The electrometer reading drove the y axis of an x-y recorder and the x axis plotted the oven temperature. The following results were obtained from our experiments:

- 1) As expected, the crystal with $\theta = 44^{\circ}$ has a substantial induced polarization whereas the crystal with $\theta = 90^{\circ}$ has virtually none. The data from this experiment is shown in Fig. 20. Both of these tests were performed with the crystals held in snug-fitting copper ovens.
- 2) The data of Fig. 21 shows that lithium niobate with $\theta = 44^{\circ}$ has a large induced polarization whereas a fused quartz substrate has none. Fused quartz is an amorphous material and hence is not expected to have a pyroelectric effect. Thus in a coating chamber, fused quartz substrates would not attract charged dust particles but lithium niobate substrates would.
- 3) Figure 22 shows the induced polarizations for a lithium niobate crystal with $\theta = 44^{\circ}$ which was mounted in three different ways. The crystal was mounted in (a) an (electrically) insulating oven, (b) a copper oven, but with the crystal protruding $1/8^{\circ}$ out the end, and (c) a copper oven with the crystal flush to the end. With the $\theta = 44^{\circ}$ orientation, polarization is induced on the sides of the crystal as well as the ends. This experiment points up the importance of having good electrical contact to the sides of the crystal in order to neutralize that polarization.
- 4) The results of Fig. 23 are for a similar experiment as in 3), but this time the crystal is lithium niobate with $\theta = 90^{\circ}$. These results show that even for $\theta = 90^{\circ}$, some net induced polarization will appear unless good electrical contact is made between the holder and the crystal sides.

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5) Tests were run in order to determine whether the induced polarization would gradually disappear with time (say, through leakage conduction inside the crystal). We found that any such decay which is present has a very long time constant. Over a 15 minute period during which the oven temperature was held constant, the induced polarization decayed less than 2%. Thus if polarization is induced in a crystal which is to be coated, that polarization will not "leak off" of its own accord.

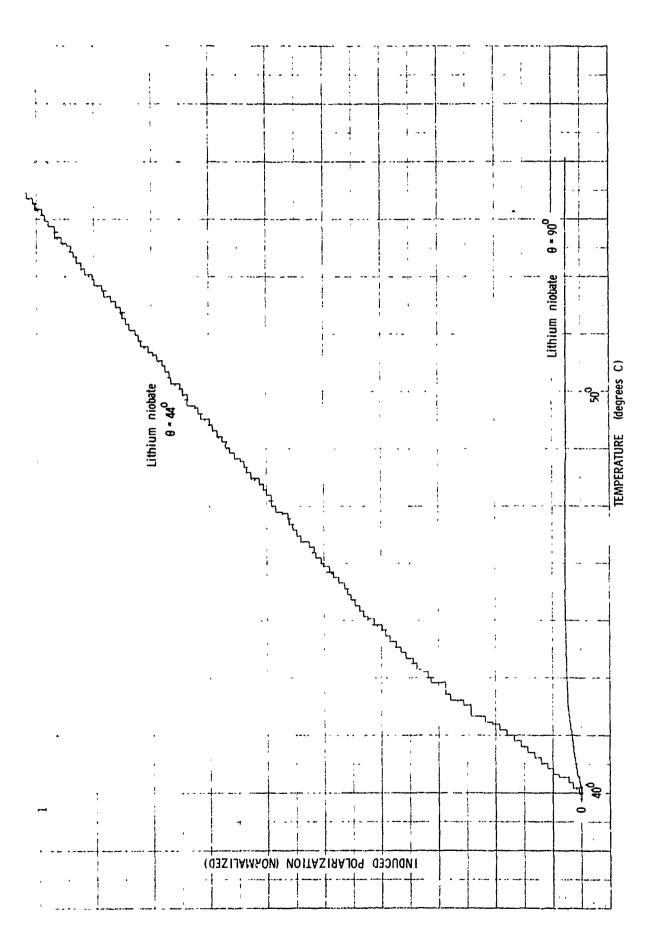


Figure 20 Pyroelectric induced polarizations for lithium niobate crystals having (a) $\theta = 44$, and (b) $\theta = 90$

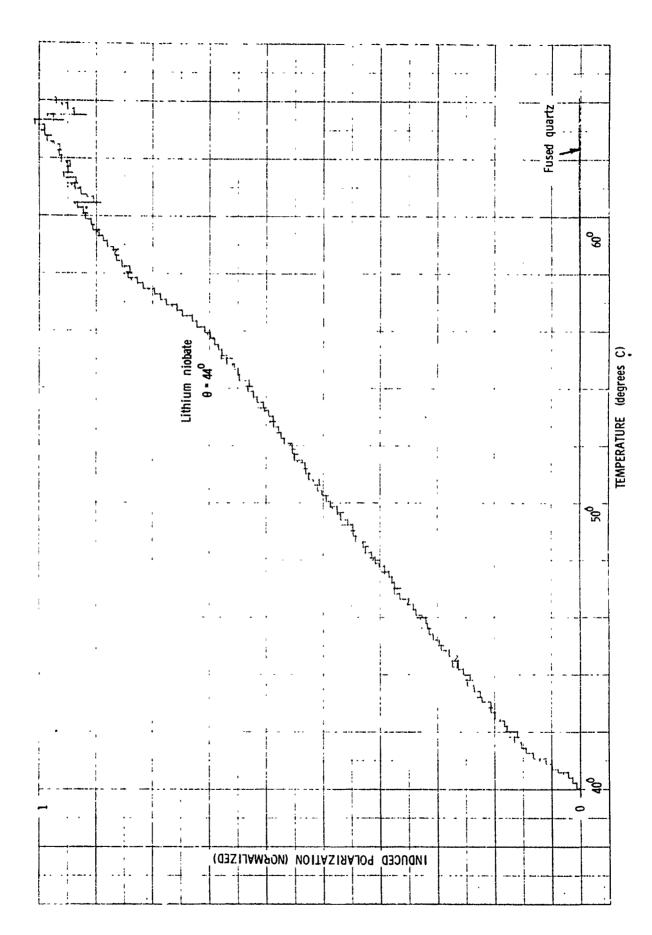
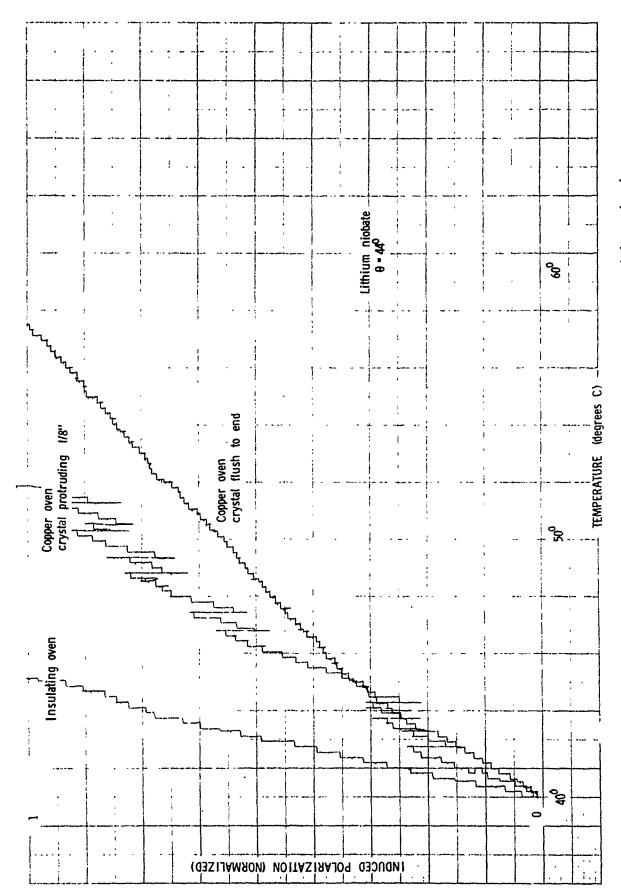
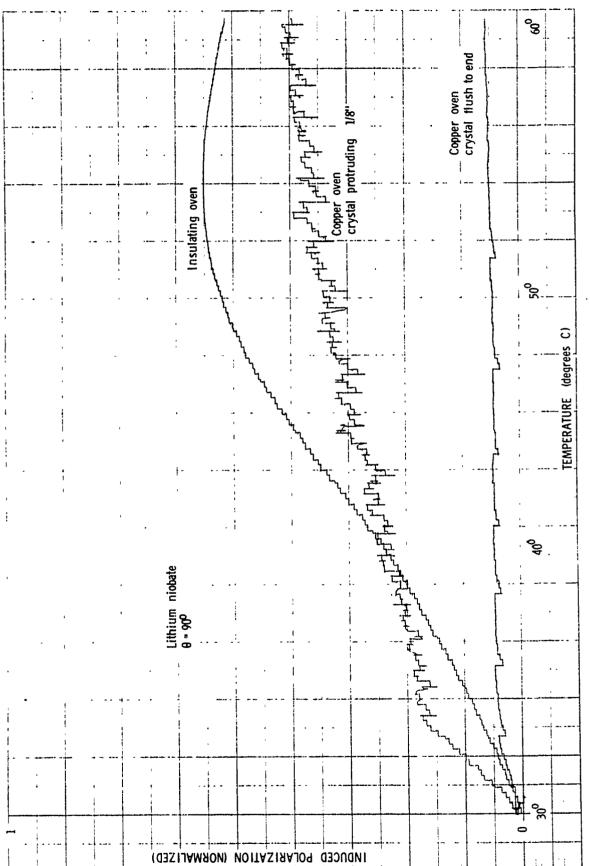


Figure 21 Pyroelectric induced polarizations for (a) lithium niobate with $\theta=44^\circ$, and (b) fused quartz substrate.



Pyroelectric induced polarizations for lithium niobate having $\theta=44^{\circ}$ for three different mountings: (a) electrically insulating oven, (b) copper oven, but with the crystal protruding 1/8" beyond the end, and (c) copper oven with crystal flush to end. Figure 22



sulating oven, (b) copper oven, but with the crystal protruding 1/8" beyond the end, and (c) copper oven with crystal flush to end. Pyroelectric induced polarizations for lithium niobate having $\theta=90^\circ$ for three different mountings: (a) electrically in-Figure 23

In light of these results, several conclusions can be stated with respect to the pyroelectric effect in lithium niobate crystals which are to be coated. In order to minimize the induced pyroelectric polarization, one could try the following approaches:

- (1) The lithium niobate crystal should be kept as near to room temperature as possible. For coatings which don't require heated substrates, one might consider circulating cooling water through the substrate holder to minimize heating. If the coating requires a heated substrate, then this problem is much more difficult to cope with.
- (2) The lithium niobate should be placed in an electrically conducting holder which makes good electrical contact with the sides of the crystal. The holder should be electrically grounded.
- (3) Care should be taken when cleaning the crystal and preparing it for insertion into the coating chamber. If, for example, the crystal is cooled during cleaning and then grounded while cool, it will have an induced polarization when it again reaches room temperature.
- (4) If the initial coating deposited were conducting, then this coating would serve to ground the crystal face. One must take care however, to use a conducting coating that has satisfactory scatter and damage properties, and this may not be easy to find.

It should be emphasized that the pyroelectric effect theory which we have discussed here has not yet been conclusively proven. This idea occurred very late in this program when insufficient time or money remained to conclusively test its validity. We feel there is a high probability that it is correct, however, and suggest that it is worthy of further investigation.

Section V

SPECTRAL TRANSMITTANCES OF FABRICATED MIRRORS

5.1 MIRROR COATING TYPES #1 AND #2

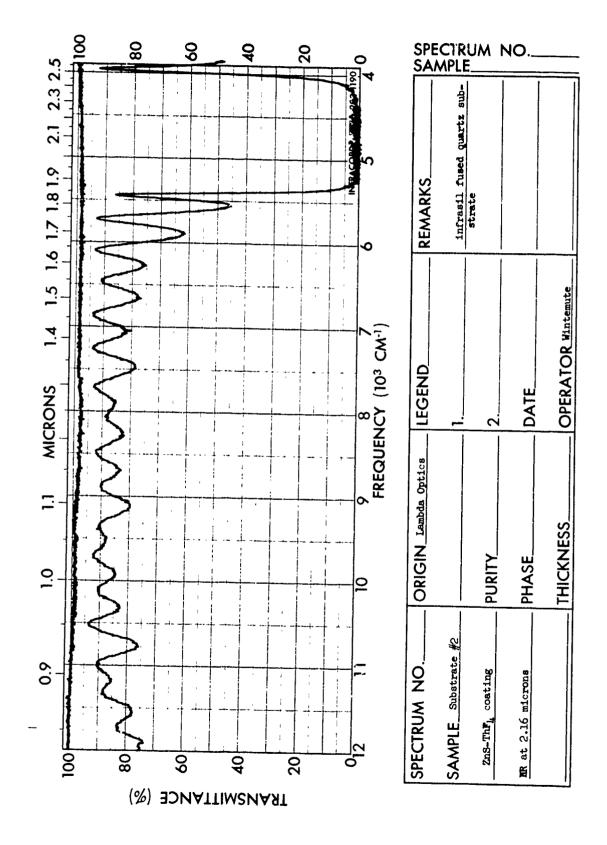
In this section, we give data on the measured spectral transmittances of oscillator coatings which are (1) HR, and (2) slightly transmitting at 2.16 microns. These types of coatings have the general designs shown in Figs. 5 and 6 and were discussed in Sections 2.3.1 and 2.3.2. The transmittances shown were measured on the PE 137G spectrophotometer shown in Fig. 12.

5.1.1 ZnS-ThF₄ Mirrors

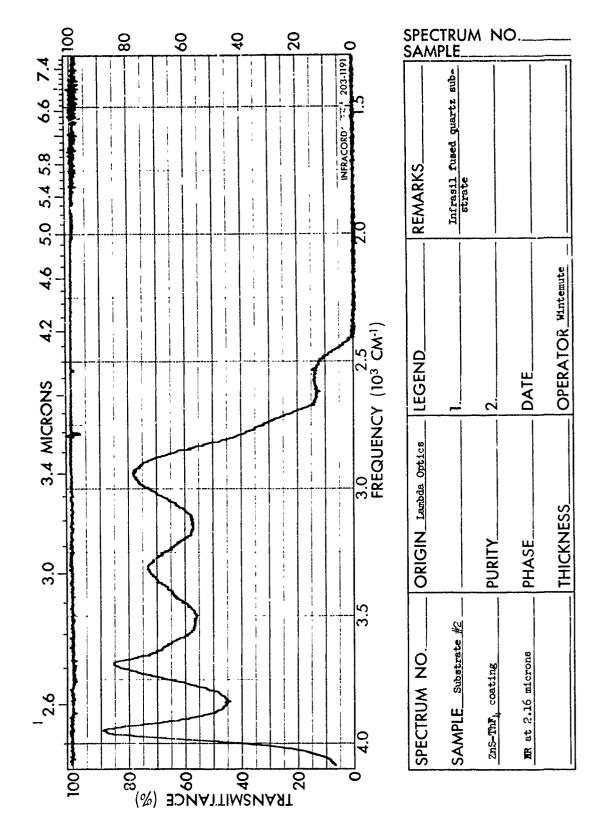
As mentioned in Section 2.1.1, ZnS and ThF₄ are materials which have excellent behavior during deposition. Their indices of refraction are well known, and do not vary appreciably during a coating run. This means that the spectral transmittance of mirrors which employ these materials can be controlled quite well.

In Figs. 24a and 24b we show the measured spectral transmittance of a ZnS-ThF₄ mirror which is HR at 2.16 microns. This mirror is on a fused quartz substrate. As seen in Figs. 24, the HR region extends from about 1.90 to 2.32 microns, a bandwidth of about 0.42 microns. At the pump wavelength of 1.08 microns the transmittance is 85%. Since the back surface of the fused quartz substrate is uncoated, the true 1.08 micron transmittance of the coating is actually more like 89% instead of 85%. All of the spectral characteristics of this coating are quite satisfactory.

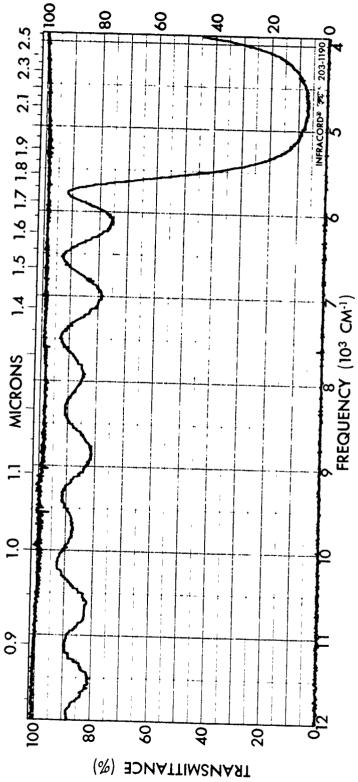
Figures 25a and 25b show the measured spectral transmittance of a ZnS-ThF₄ mirror which is slightly transmitting at 2.16 microns. This mirror is also on a fused quartz substrate. The transmission is approximately 7% at 2.15 microns. The 1.08 micron pump transmission is 90%. It should be noted that the bandwidth of the transmitting mirror is smaller than that of the HR mirror. This characteristic is inherent in the mirror designs of Figs. 5 and 6. The bandwidth of a doubly-resonant 2 micron parametric oscillator is essentially limited by the bandwidth of the transmitting coating. A recommendation for future work in this area is that studies be carried out to develop partially transmitting mirror designs with greater bandwidths than presently attainable.



Measured spectral transmittance of ${\tt ZnS-ThF}_4$ mirror which is HR at 2.16 microns. Figure 24 (a)

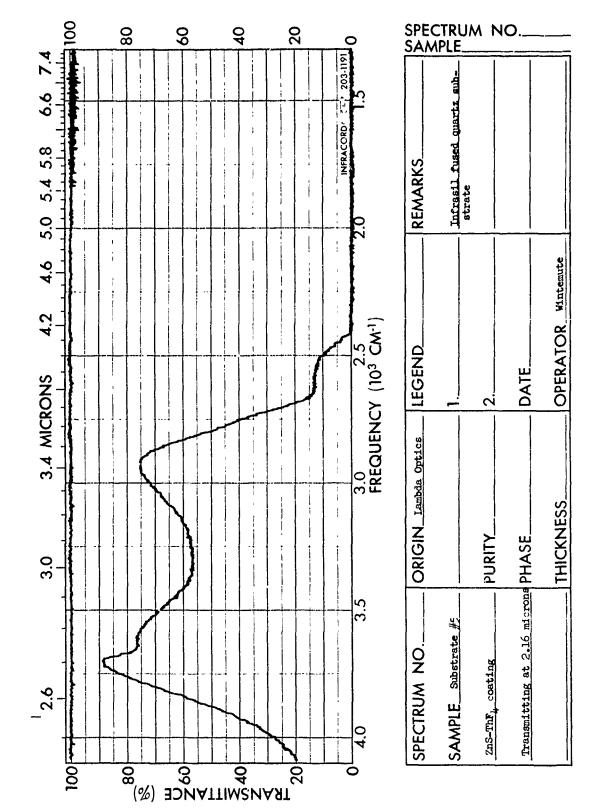


 $24~{\rm Measured}$ spectral transmittance of ${\rm ZnS-ThF}_4$ mirror which is HR at 2.16 microns. Figure 7 (b)



ORIGIN_lambda Optics LEGEND REMARKS 1.
Lembda Optics
ORIGIN Lambda Optics PURITY PHASE THICKNESS
SPECTRUM NO. ORIGIN SAMPLE_Substrate #5 ZnS-ThF, coating PURITY Transmitting at 2.16 microns PHASE THICKN

Heasured spectral transmittance of ${\rm ZnS-ThF}_4$ mirror which is slightly transmitting at 2.16 microns. Figure 25 (a)



mirror which is Figure 25 Measured spectral transmittance of ZnS-ThF $_4$ (b) slightly transmitting at 2.16 microms.

5.1.2 EnS-ThF₄ Overcoated with Al₂0₃

An important question is whether the half-wave overcoating of Al $_2^0$ 3 affects the spectral transmittance of ZnS-ThF $_4$ mirrors. In Figs. 26a and 26b we show measured spectral transmittances for HR ZnS-ThF $_4$ coatings with and without an Al $_2^0$ 3 overcoating. The ZnS-ThF $_4$ portions of these two coatings were deposited at the same time. It can be seen from Figs. 26 that the transmittance of the ZnS-ThF $_4$ coating is virtually unaffected by the presence of an Al $_2^0$ 3 overcoating. The slight differences in transmittance which do occur in Figs. 26 are due to other causes as will be explained in Section 5.3.

Figures 27a and 27b show transmittances for transmitting 2 micron coatings of ZnS-ThF₄ with and without Al_2O_3 overcoatings. Again we see that the overcoating has a negligible effect on the coating transmittance.

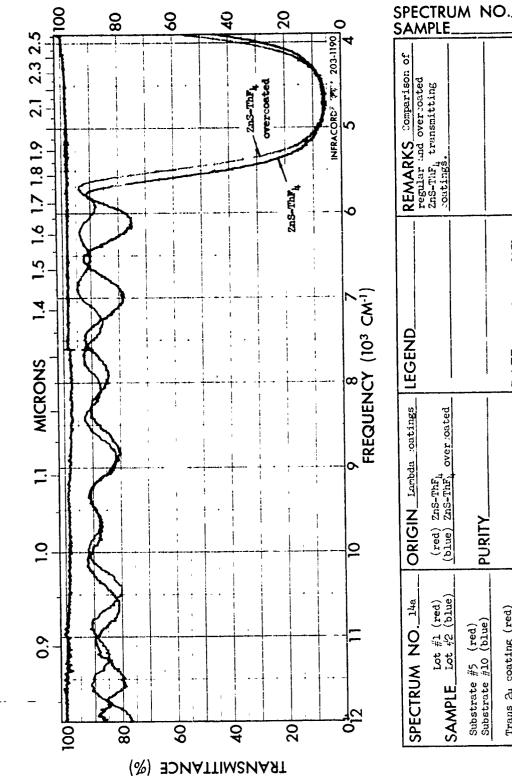
5.1.3 ZnS-Cryolite Mirrors

Cryolite is another material having reproducible, well behaved coating properties. Thus we would not expect to encounter difficulties in obtaining desired transmittances with ZnS-cryolite mirrors. The spectral transmittance of an HR ZnS-cryolite mirror is shown in Figs. 27a and 27b. The HR region of this mirror extends from 1.86 to 2.42 microns, covering a region of 0.56 microns. This bandwidth is greater than that obtainable from ZnS-ThF₄ mirrors because of the greater difference in indices of ZnS and cryolite. The 1.08 micron transmission is 87%, which is quite acceptable.

The spectral transmittance of a transmitting 2 micron ZnS-cryolite coating is given in Figs. 28a and 28b. The coating has transmission of 4% at a wavelength of 2.15 microns, and a transmission of 91% at 1.08 microns. Again the bandwidth of this coating is greater than that of the corresponding ZnS-ThF $_{\Delta}$ coating because of the indices of the materials involved.

5.1.4 ZnS-Cryolite Overcoated with Al_2O_3

The transmittances of HR and transmitting overcoated ZnS-cryolite mirrors are shown in Figs. 30 and 31, respectively. The ${\rm Al}_2{\rm O}_3$ overcoating again causes no problems with mirror transmittance and, if anything, slightly increases the transmittance away from the 2 micron region. The wavelength effect of Fig. 30 is not due to the overcoating as mentioned earlier, but will be explained later.



REMARKS Comparison of regular and overcoated	ZnS-Tir, transmitting			
			DATE Desember 0, 1971	OPERATOR 3. Wintemute
ORIGIN Lambda coatings LEGEND	(red) ZnS-ThF _h (blue) ZnS-ThF _h over oated	PURITY	PHASE	THICKNESS
SPECTRUM NO. 148	SAMPLE Lot #1 (red)	Substrate #5 (red) Substrate #10 (blue)	Trans 2 coating (red) Trans 2 coating (blue)	

Comparison of spectral transmittances of ${\rm ZnS-ThF}_4$ mirrors with and without ${\rm Al}_2{}^0{}_3$ overcoatings which are HR at 2.16 microns. 26 Figure (a)

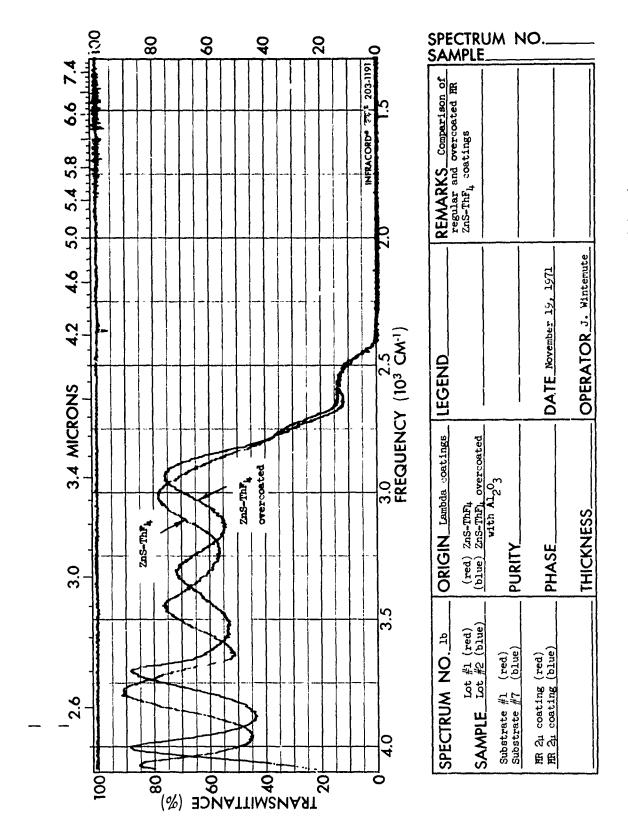
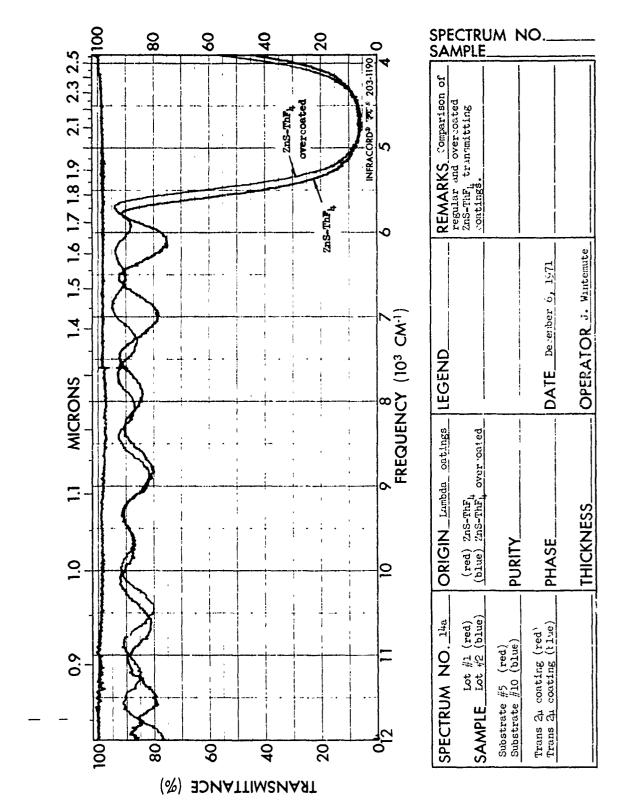
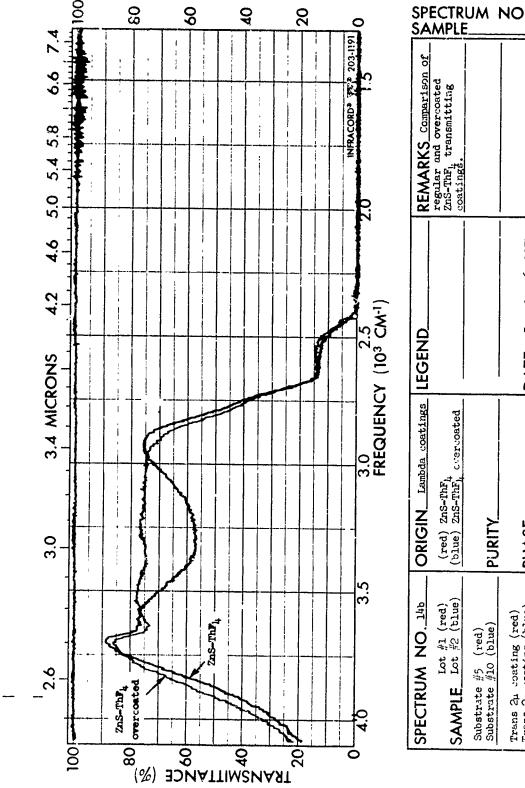


Figure 26 Comparison of spectral transmittances of ${\rm ZnS-ThF}_4$ mirrors (b) with and without ${\rm Al}_2{}^0{}_3$ overcoatings which are HR at 2.16 microns.



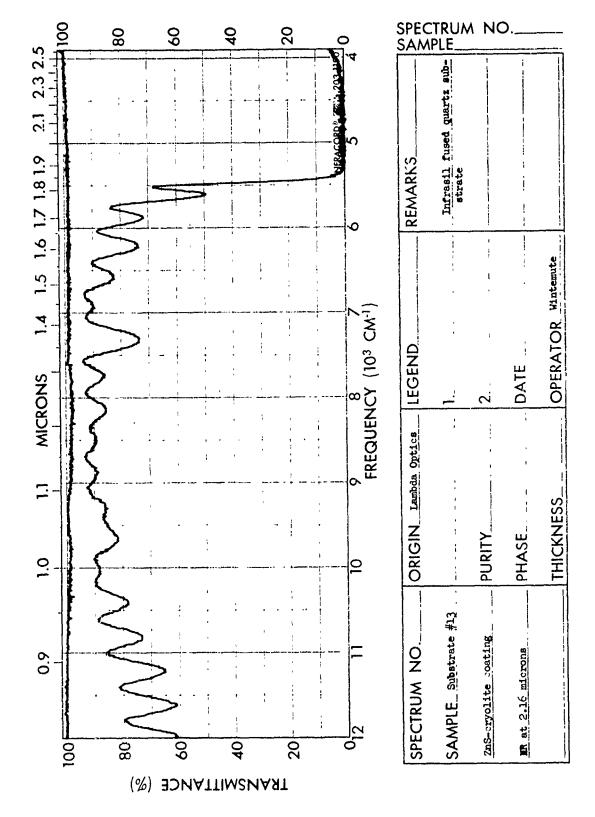
Comparison of spectral transmittances of ${\rm ZnS-ThF}_4$ mirrors with and without ${\rm Al}_2^{~0}{}_3$ overcoatings which are slightly transmitting at 2.16 microns. 27 Figure (a)

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SPECTRUM NO. 14b	ORIGIN Lambda coatings LEGEND	LEGEND	REMARKS comparison of
SAMPLE Lot #2 (tlue)	(red) ZnS-ThF _t (blue) ZnS-ThF _t cvercoated		regular and overcoated ZnS-ThF ₁ transmitting coatings.
Substrate #5 (red) Substrate #10 (blue)	PURITY		
Trans 2 coating (red) Trans 2 coating (blue)	PHASE	DATE December 6, 1971	
	THICKNESS	OPERATOR J. Wintemute	

Figure 27 Comparison of spectral transmittances of $2nS-ThF_4$ mirrors with (b) and without Al_2^{0} overcoatings which are slightly transmitting at 2.16 microns.



Measured spectral transmittance of ZnS-cryolite mirror which is HR at 2.16 microns. Figure 23 (a)

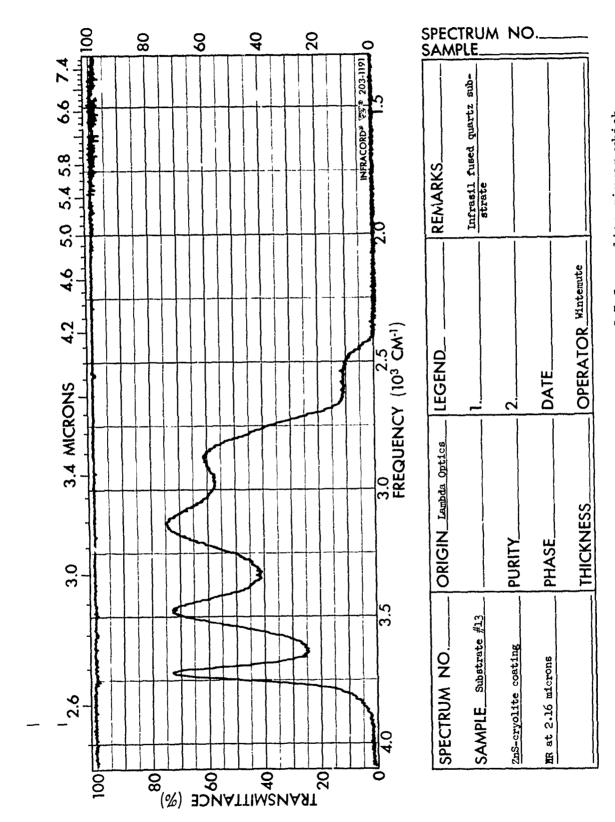
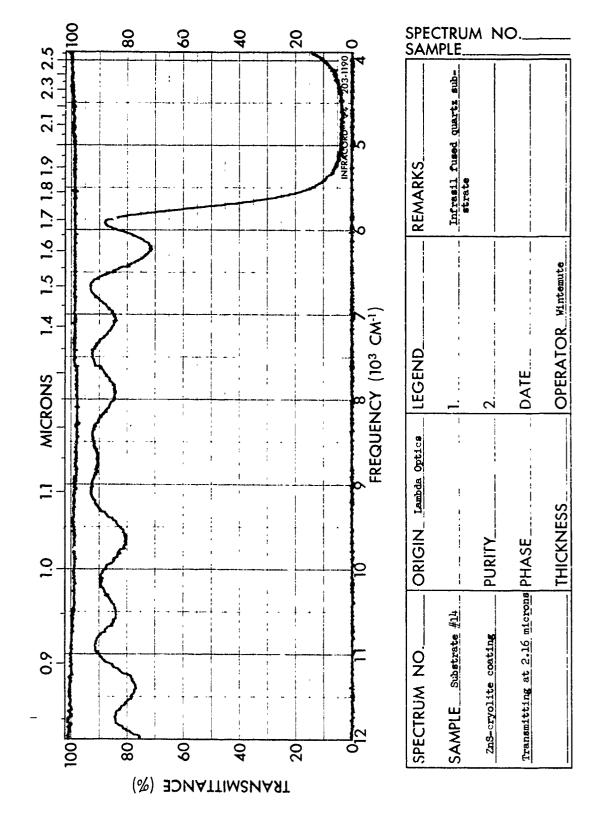


Figure 28 Measured spectral transmittance of ZnS-cryolite mirror which (b) is HR at 2.16 microns.



Measured spectral transmittance of ZnS-cryolite mirror which is slightly transmitting at 2.16 microns. 29 Figure ? (a)

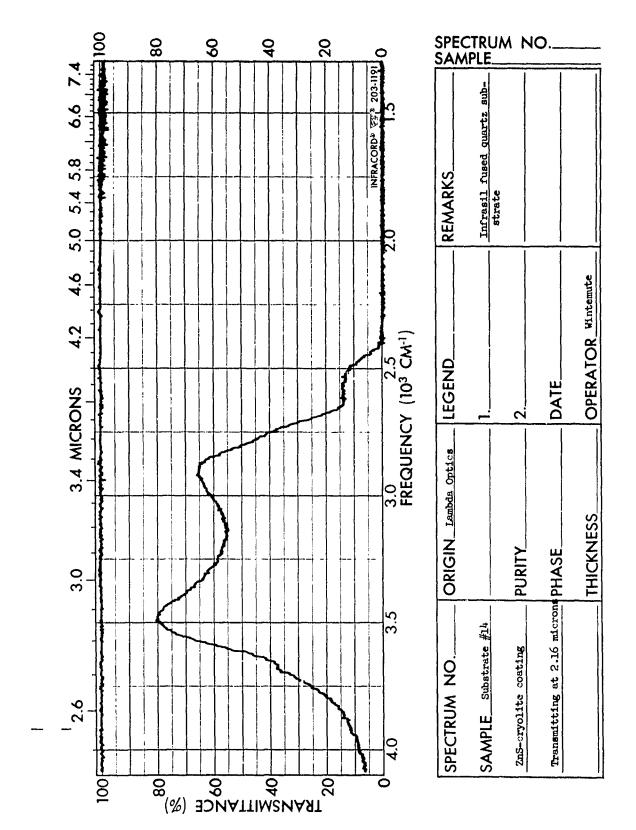
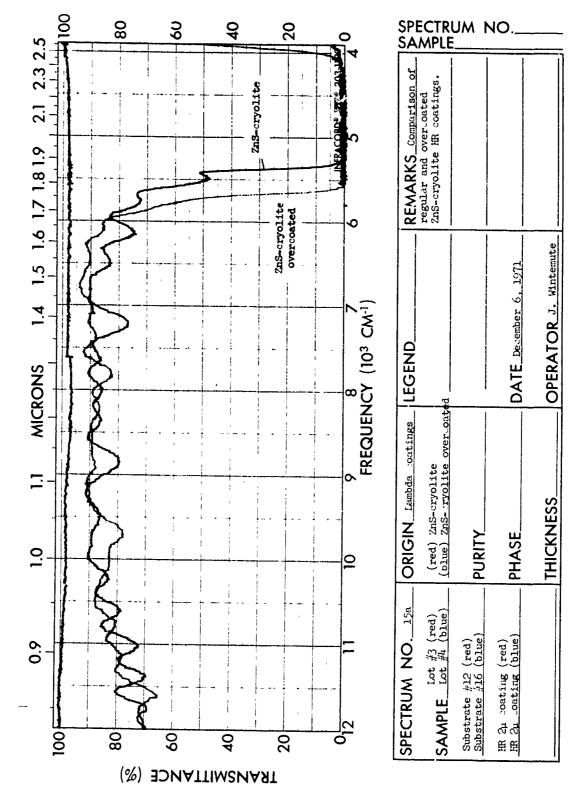
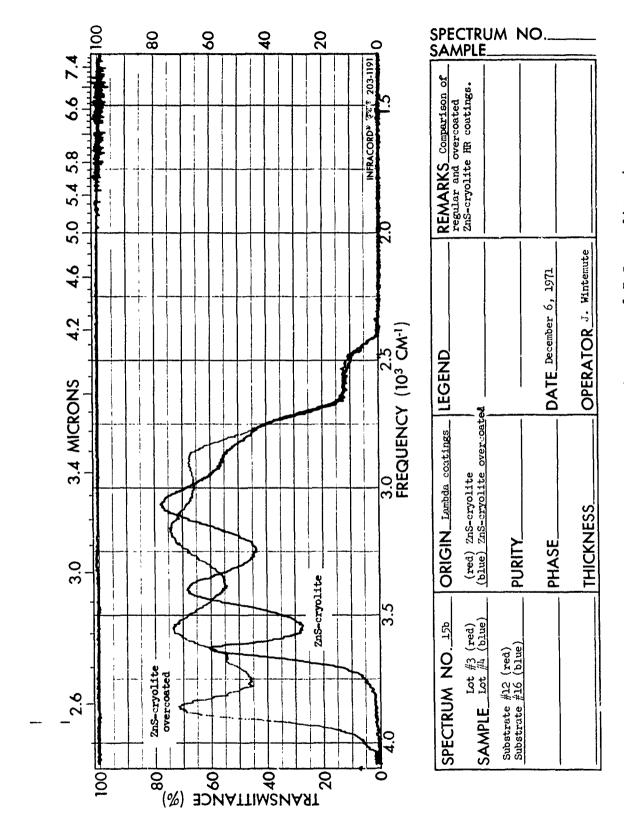


Figure 29 Measured spectral transmittance of ZnS-cryolite mirror which (b) is slightly transmitting at 2.16 microns.

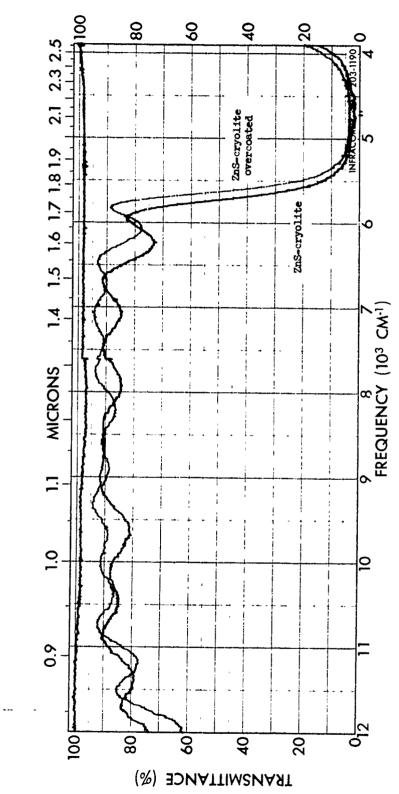


with and without ${\rm Al}_2{\rm O}_3$ overcoating which are HR at 2.16 microns. Comparison of spectral transmittances of ZnS-cryolite mirrors Figure 30 (a)



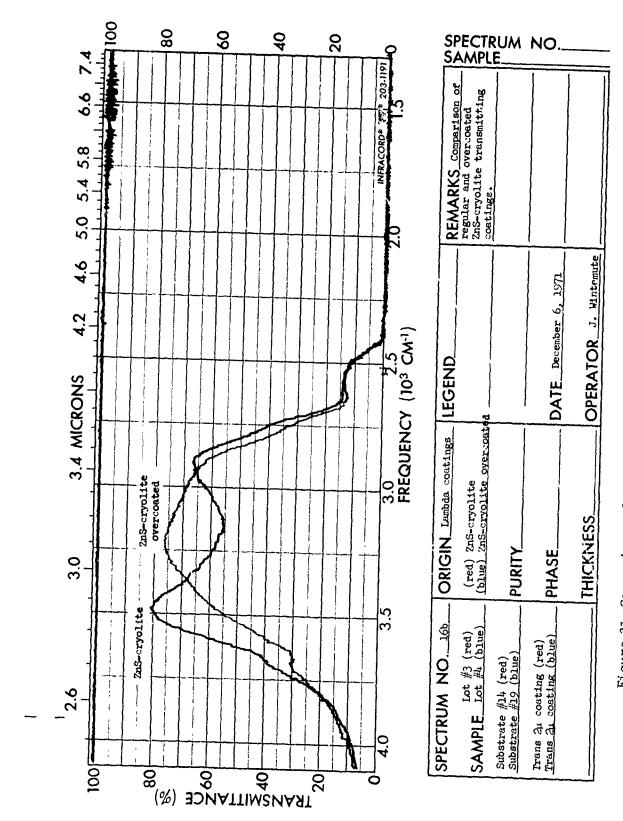
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with and without Al_20_3 overcoating which are HR at 2.16 microns Comparison of spectral transmittances of ZnS-cryolite mirrors Figure 3C (b)



ORIGIN (red) ZnS (blue) ZnS (blue) ZnS PURITY PHASE THICKN	ORIGIN Lambda cogtungs [LEGEND REMARKS comparison of	oxer, oated		DATE Desember 6, 1971	ESSOPERATOR J. Wintemute
	ORIGIN	(red) ZnS-cryolite	PURITY	PHASE	THICKNESS

Comparison of spectral transmittances of ZnS-cryolite mirrors with and without $Al_2^{\ 0}$ overcoating which are slightly transmitting at 2.16 microns. Figure 31 (a)



Comparison of spectral transmittances of ZnS-cryolite mirrors with and wit out $\mathrm{Al}_2^{0,3}$ overcoating which are slightly transmitting at 2.16 microns. Figure 31 (b)

5.1.5 ZnS-ThF₄ Undercoated and Overcoated with Al₂0₃

Figures 32 and 33 show measured transmittances for ${\rm ZnS-ThF}_4$ coatings which are undercoated and overcoated with ${\rm Al}_2{\rm O}_3$. By comparing these with the results of Figs. 24 and 25, we see that the undercoating and overcoating have negligible effect on the mirror transmittance. Thus in none of the cases investigated did ${\rm Al}_2{\rm O}_3$ have an adverse effect upon the coating transmittance.

5.1.6 Spectrum Systems Coatings

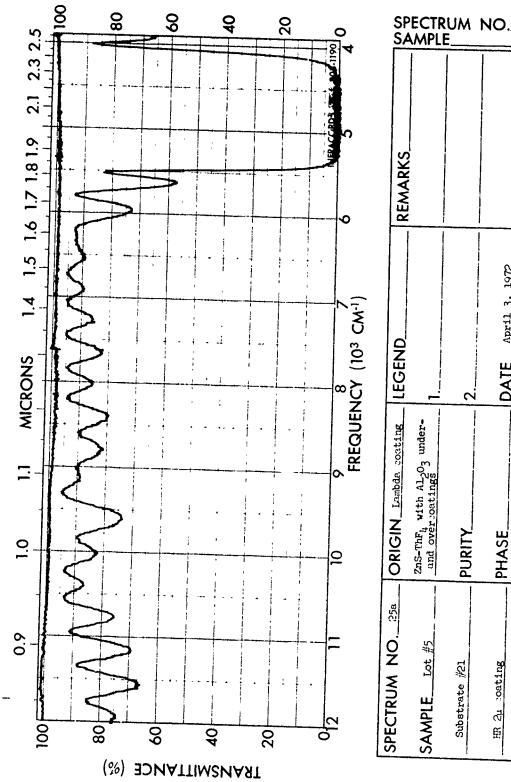
The spectral transmittance of HR and transmitting coatings from Spectrum Systems are shown in Figs. 32 and 33. As mentioned earlier, some of the very durable coating materials can offer difficulties during deposition. Often the index of refraction will vary during a coating run making it difficult to achieve a desired transmittance exactly. A second difficulty which is not uncommon is that the coating materials decompose during deposition because of the high temperatures required. The new materials thus formed have an incorrect index of refraction and may even be absorbing in the wavelength region of interest.

In Figs. 34 and 35 we show measured transmittance of the Spectrum Systems mirrors. For the HR coating of Fig. 34, the HR range is quite large, extending from 1.78 microns to 2.8 microns! Unfortunately in the middle of this region at 2.35 microns, the coating becomes somewhat transmitting. An even worse problem, however, is that the 1.08 micron transmission is only about 45%. This is an unacceptably low value.

The transmitting mirror of Fig. 35 also has this problem. Its 1.08 micron transmission is about 65%, a value which is still too low. The bandwidth of the transmission region is very large, a highly desirable feature. For both Figs. 34 and 35 an uncoated quartz substrate was placed in the reference beam of the spectrometer. The mirror transmission data of Figs. 34b and 35b is valid up to 4 microns, but not beyond because of substrate absorption.

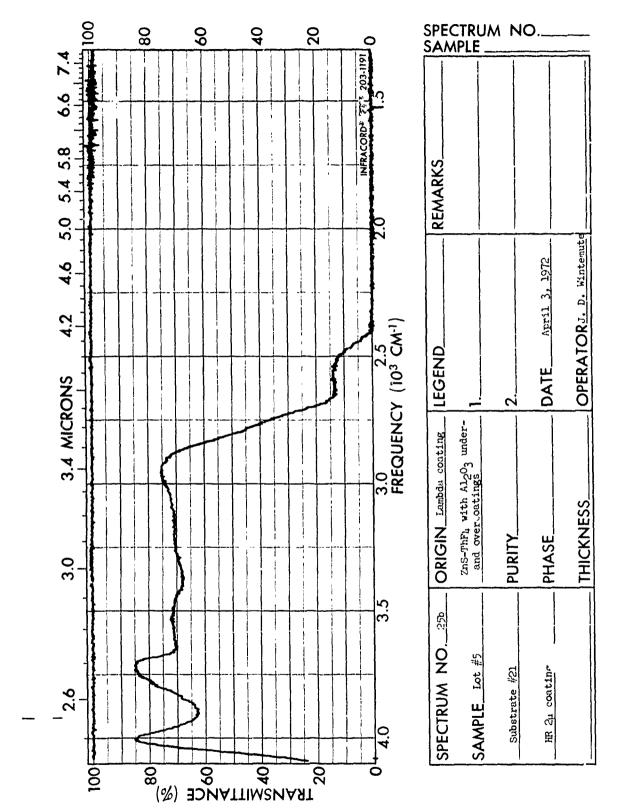
5.2 MIRROR COATING TYPE #3

As described in Section 2.3.3, this type of coating is designed to be highly reflecting at the oscillator signal wavelength, while having slight transmission at the idler wavelength. $ZnS-ThF_4$ coatings of this type were fabricated with the following design parameters: signal wavelength - 1.56 microns; idler wavelength - 3.5 microns; signal transmission - HR; idler

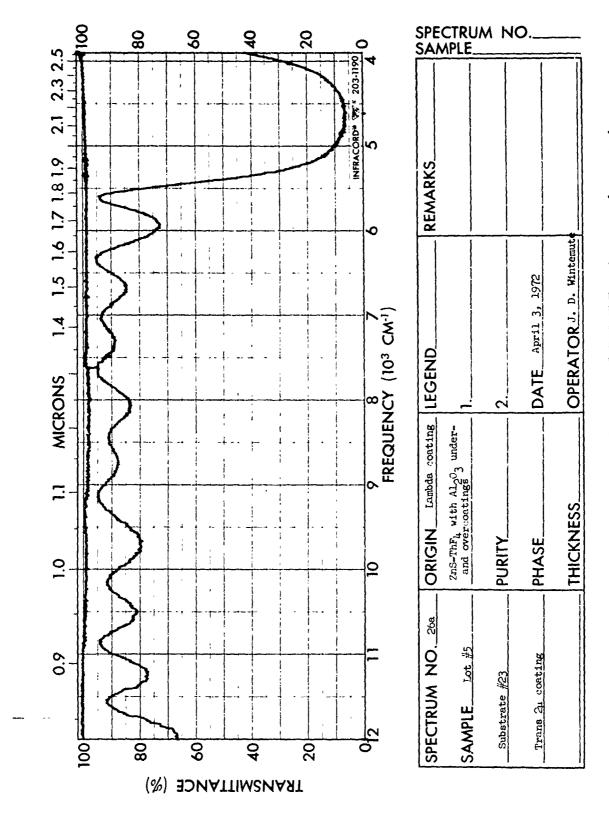


NO. 25a ORIGIN Lambde coating LEGEND REMARKS	ZnS-ThF _t with Al ₂ O ₃ under- and overcoatings	PURITY 2.	PHASE	THICKNESS
	SAMPLE Lot #5	Substrate #21	HR 2u coating	

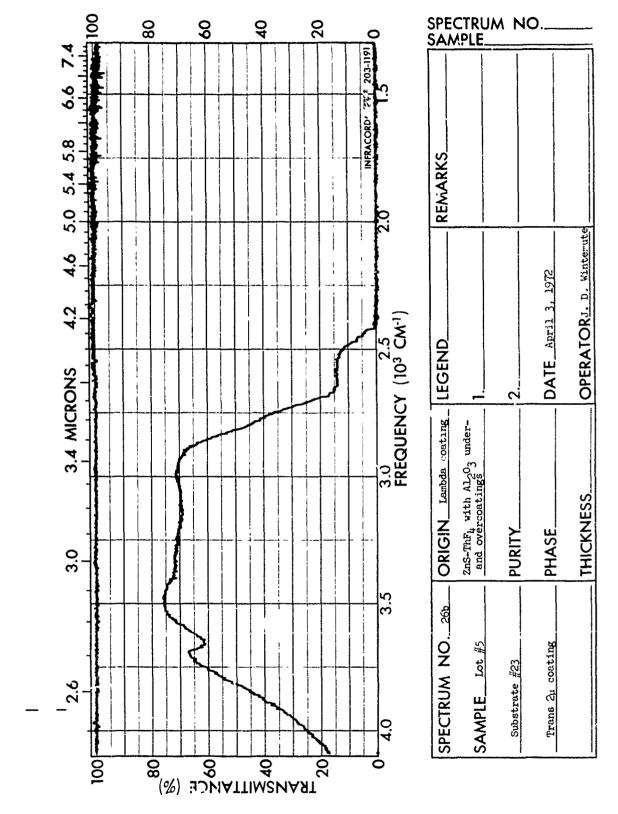
Heasured spectral transmittance of ZnS-ThF, mirror undercoated and overcoated with ${\rm Al}_2{}^0{}_3$ which is HR at 2.16 microns. Figure 32 (a)



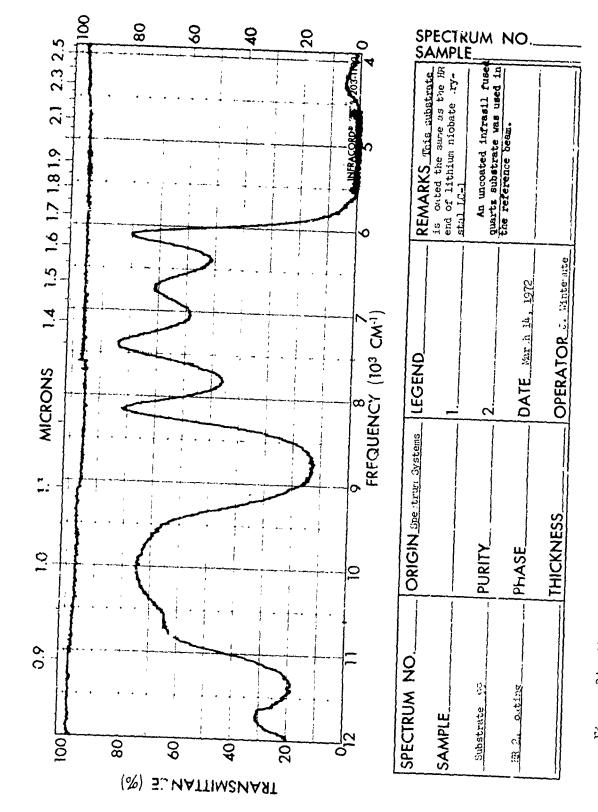
Heasured spectral transmittance of ZnS-ThF, mirror undercoated and overcoated with ${\rm Al}_2{\rm O}_3$ which is HR at 2.16 microns. Figure 32 (b)



mirror undercoated Measured spectral transmittance of ${\rm ZnS-ThF}_4$ mirror undercoat and overcoated with ${\rm Al_20_3}$ which is slightly transmitting at 2.16 microns. Figure 33 (a)



Measured spectral transmittance of ${\rm ZnS-ThF}_4$ mirror undercoated and overcoated with ${\rm Al}_2{\rm O}_3$ which is slightly transmitting at 2.16 microns. Figure 33 (b)



Measured spectral transmittance of Spectrum Systems mirror which is HR at 2.16 microns. Figure 34 (a)

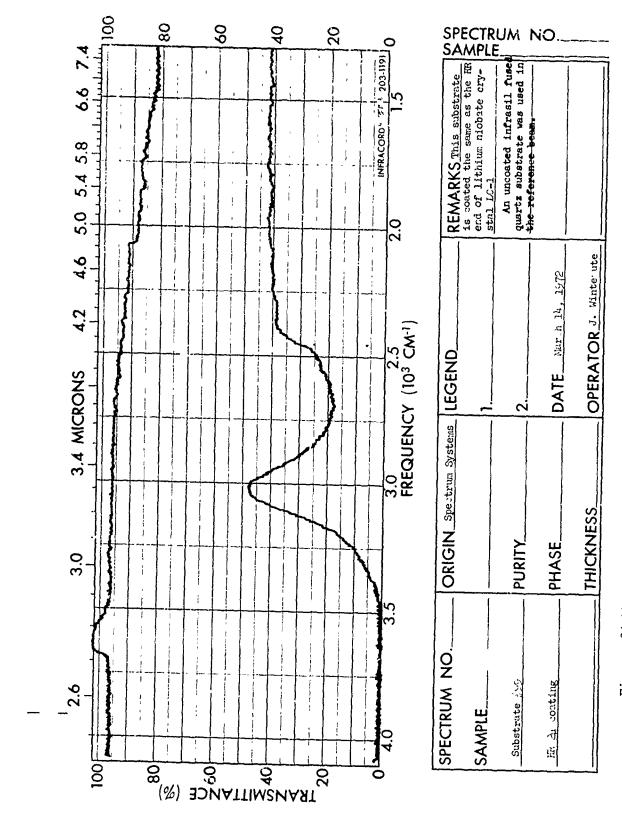
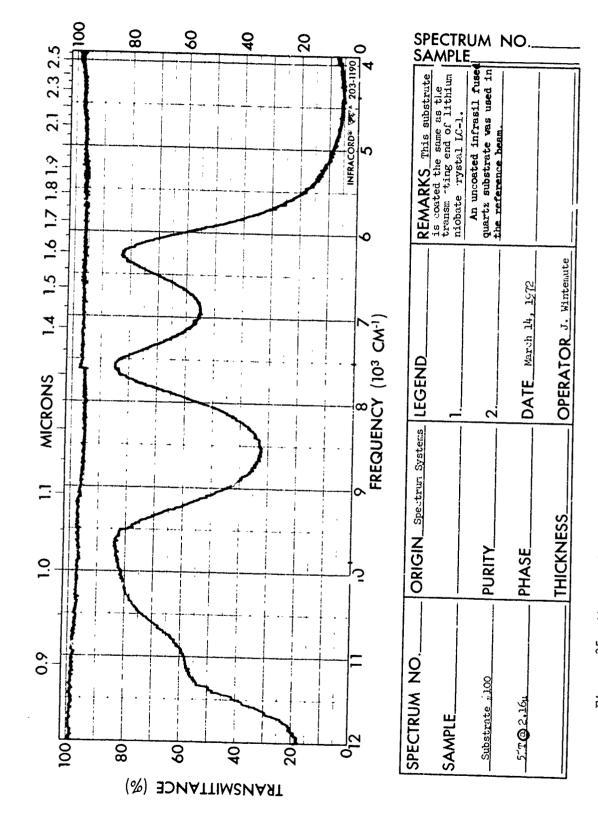


Figure 34 Measured spectral transmittance of Spectrum Systems mirror (b) which is HR at 2.16 microns.



Heasured spectral transmittance of Spectrum Systems mirror which is slightly transmitting at 2.16 microns. Figure 35 (a)

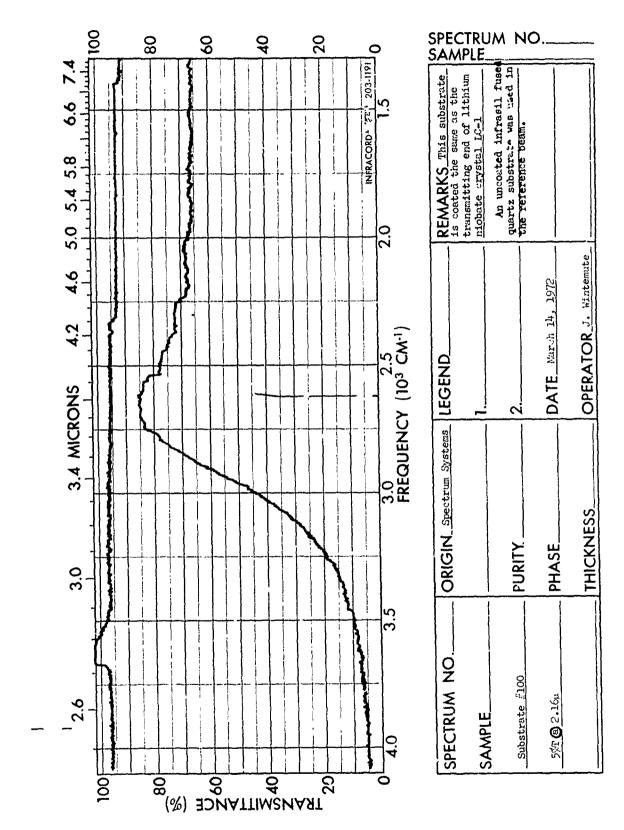


Figure 35 Measured spectral transmittance of Spectrum Systems mirror (b) which is slightly transmitting at 2.16 microns.

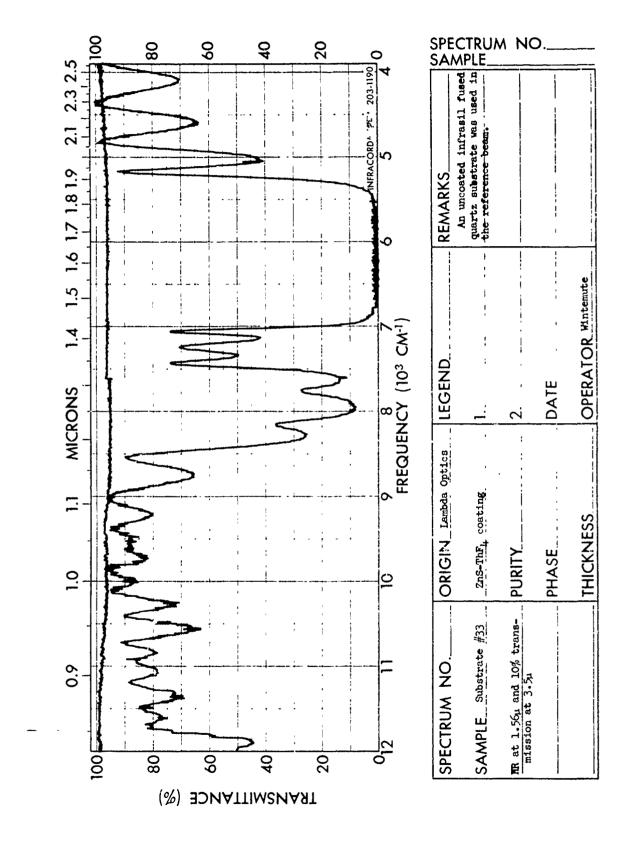
transmission - 10%; and 1.08 micron pump transmission - 80% or greater.

Measured transmission of the ZnS-ThF $_4$ type #3 mirror is given in Fig. 30. The HR region extends from 1.47 to 1.84 microns, and the 1.08 micron transmission is 86%. The idler transmission ranges from 8 to 18% over the wavelength range 3.3 to 3.7 microns. Thus all of the design parameters were met by this coating.

5.3 GENERAL OBSERVATIONS

We have previously noted in Section 2.3.2 that mirror reflectivities varied somewhat when different substrates were employed. The data of Table 2 show that midband coating transmission is somewhat greater for a fused-quartz substrate than for lithium niobate. The transmission curve of Fig. 37 gives experimental proof of this phenomenon. The two curves of Fig. 37 show transmissions of the same $ZnS-ThF_4$ coating on fused quartz and on lithium niobate. The midband (2.1 micron) transmittances are 7% and 4%, respectively. This agrees quite well with the data of Table 2 for n=10.

We also note that coating transmissions can vary somewhat from sample to sample even when the substrates are made of the same material. Figure 38 shows transmissions of two fused quartz substrates which were coated at the same time. It can be seen that the curves are similar in shape, but shifted in wavelength by about .06 microns. Thus there can be substantial variations from piece to piece in a given coating run. The transmission of the "monitor piece" will not necessarily be the same as the transmissions of the other pieces from that same lot. The safest procedure is to measure the transmittance of the piece in question directly.



deasured spectral transmittance of 3.5 micron doubly-resonant ${\rm ZnS-ThF}_4$ mirror. Figure 36 (a)

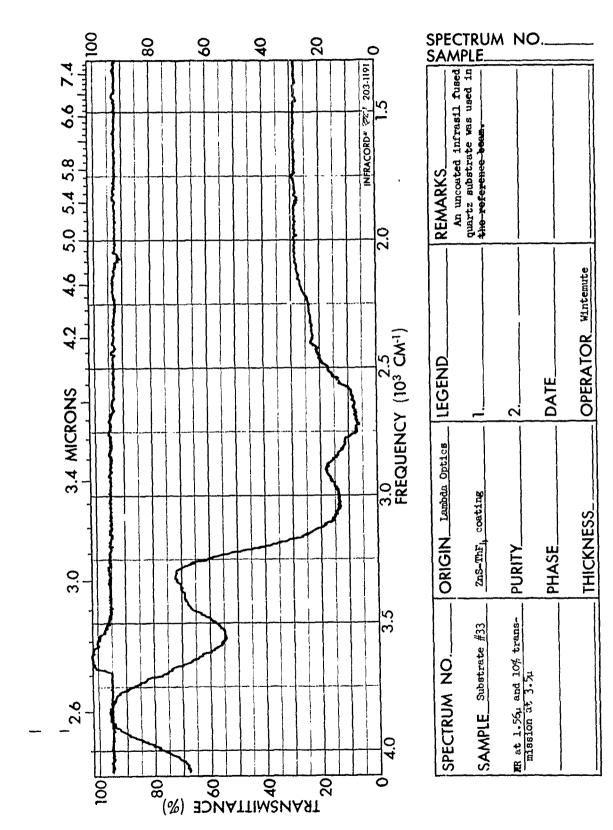


Figure 36 Measured spectral transmittance of 3.5 micron doubly-resonant (b) ZnS-ThF $_4$ mirror.

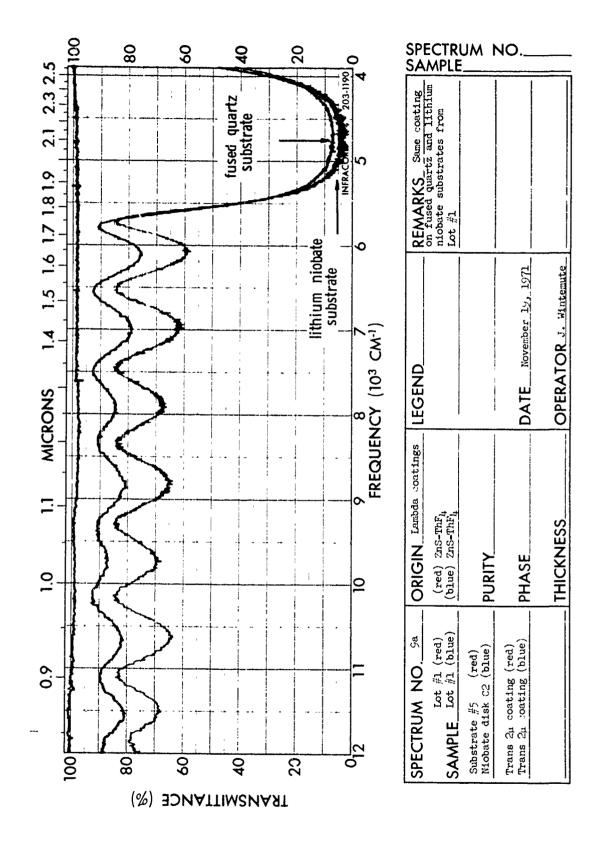
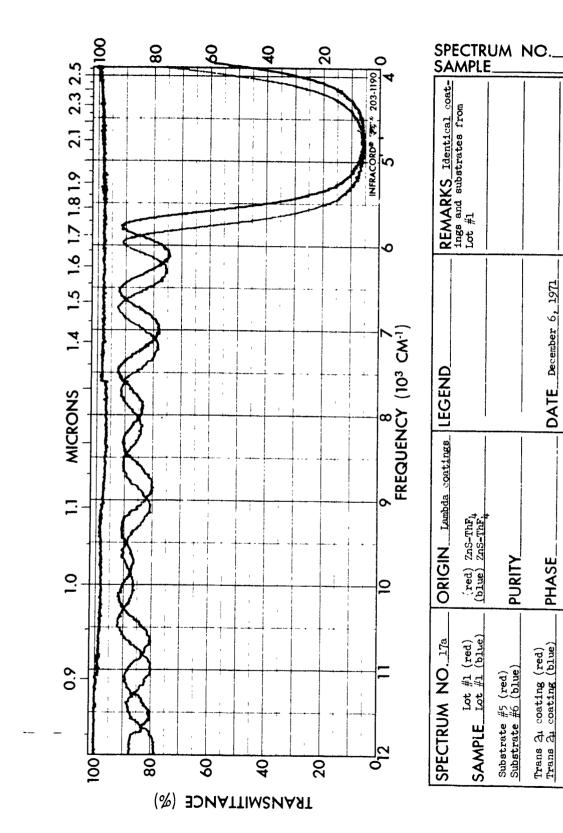


Figure 37 Dependence of spectral transmittance upon substrate.



Variation from substrate to substrate of spectral transmittance. Figure 38

OPERATOR J. Wintemute

THICKNESS

Section VI

DAMAGE MEASUREMENTS ON FABRICATED MIRRORS

An important part of this program has been to measure the power densities at which optical damage occurs to the various oscillator coatings (and substrates). In addition, we have sought ways of improving these damage levels. The results of our investigations on damage are given in this section.

6.1 TYPES OF DAMAGE ENCOUNTERED

Several different types of damage have been encountered in our damage investigations. Damage can (and has) occurred to the coatings themselves, the substrates, and to dust particles on the coatings. As a first step in this work, we sought to identify and characterize the various types of damage. Each of the types of damage listed below has been observed both with the external test setup of Fig. 13 and in actual parametric oscillator experiments.

In order to help clarify the causes of the different types of damage, tests were run on (1) uncoated lithium niobate and uncoated fused quartz substrates (2) coated lithium niobate, and (3) coated fused quartz. The results of these tests and the conclusions reached from them will now be given.

The first type of damage consists of a central damaged area surrounded by concentric cracked layers of coatings. No material is sprayed onto the surface of the coating. This type of damage is observed with coated quartz and lithium niobate substrates, but not with uncoated substrates. An example is shown in Fig. 39a where the two major damage spots illustrate this type of damage. The magnification for Fig. 39a is 77. We believe that this represents damage which occurs to one of the intermediate layers of the coating. The layers lying above the damaged area are cracked, perhaps from thermal stresses. One can tell approximately which layer of the coating has damaged by noting the number of rings surrounding the damage. In the remainder of this report, we will refer to this type of damage as "crater damage".

The second type of damage which we have encountered consists of a hole which extends completely through the coating layers into the lithium niobate substrate. A good deal of material is thrown out and scattered around

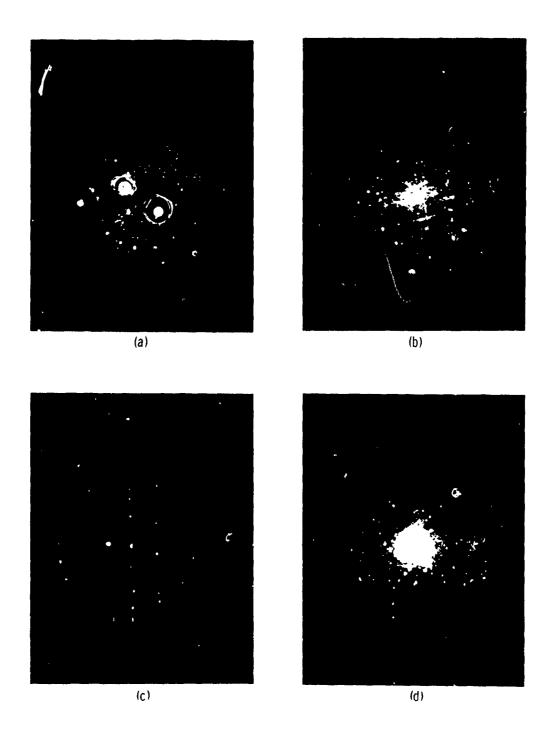


Figure 39 Types of coating and substrate damage encountered on this program:
(a) crater (coating) damage; (b) lithium niobate (substrate)
damage; (c) small-spot (coating) damage; and (d) dust damage.

the hole; most of this material cleans off when the coating (or uncoated crystal) is scrubbed with a Q-tip moistened with acetone. We have observed this type of damage with both coated and uncoated lithium niobate, but have not observed it with uncoated or coated fused quartz. We therefore deduce that this damage represents damage to the lithium niobate substrate. An example of this type of damage is shown in Fig. 39b near the center of the photo. We refer to this type of damage as lithium niobate damage.

A third type of damage consists of numerous small spots having diameters of perhaps 5 microns. These are probably shown most clearly in Fig. 39c where they occur in straight lines (the crystal was translated linearly during damage tests). The magnification for Fig. 39c is 27. These small spots can also be seen randomly arranged around the crater and niobate damages of Figs. 39a and 39b. We observe this type of damage with coatings on quartz and niobate; we do not observe it with uncoated quartz or niobate. We believe that this damage occurs in the top (ZnS) layer in the mirror coating. With this type of damage, there are no circular cracks surrounding the spot, and no material is thrown onto the surface. This type of damage is of special interest and importance, and is discussed again later in Section 6.3. We call this particular type of damage "small-spot damage".

The fourth and final type of damage which we have observed is caused by the laser beam striking dust particles lying on the mirror surfaces. This type of damage can cover a fairly large area, and often throws out material onto the coating. Some, but not all of this can be cleaned off by scrubbing with a Q-tip. An example of this type of damage is shown in Fig. 39d (77 times magnification). Because of the splattering, this type of damage is somewhat similar in appearance to lithium niobate damage, but does not extend down through the coating nor into the substrate. Careful cleaning of the mirrors prior to testing (or operation of an oscillator) is needed in order to minimize this type of damage.

6.2 LITHIUM NIOBATE DAMAGE LEVELS

One of the important and rather surprising results obtained on this program is that the presence of a coating can significantly affect the level at which lithium niobate surface damage (of the type shown in Fig. 39b) occurs.

Table III

1.08 Micron Damage Thresholds for Lithium Wiobate with Various Coatings

Peak power density at which surface damage begins MW/cm	46 MW/cm ²	$54 - 61 \mathrm{MW/cm}^2$	61 MW/cm ²	$107 - 115 \mathrm{MW/cm}^2$	150 MW/cm ²	86, 150 MW/cm ²
Coating on LiNb0_3	uncoated	ZnS - Th \mathbb{F}_4 multilayer	ZnS-cryolite multilayer	ZnS - ThF $_{4}$ multilayer overcoated with $\mathrm{Al}_{2}^{0}_{3}$	$\lambda/4$ layer of Al ₂ 0 ₃	ZnS - Th F_{4} multilayer under and overcoated with Al $_{2}^{0}$ 3

Since lithium niobate surface damage occurs at approximately the same levels as does coating damage, and since we are able to separately identify the two types of damage, we are able to present lithium niobate damage data. The tests were performed on coated and uncoated lithium niobate disks using the test setup of Fig. 13. Other conditions of the test are the same as described in Section 3.4. It should be emphasized that the variance in lithium niobate damage results is somewhat greater than in coating damage tests. Thus in some cases, a range of values is given rather than a single value. Nonetheless, certain trends are clearly discernable. Our results are listed in Table 3.

Tests were initially run on uncoated lithium niobate disks and damage was found to occur at about $46~\mathrm{MW/cm^2}$. Fests were next run on a disk with a $\mathrm{ZnS-ThF_4}$ multilayer coating; in this case damage occurred at about the 54 to $61~\mathrm{MW/cm^2}$ levels. Disks having $\mathrm{ZnS-cryolite}$ multilayer coatings were also found to damage at about $61~\mathrm{MW/cm^2}$. The next tests were performed on disks having $\mathrm{ZnS-ThF_4}$ multilayers overcoated with $\mathrm{Al_20_3}$. For these overcoated mirrors, the $\mathrm{LiNb0_3}$ damage level increased to $107-115~\mathrm{MW/cm^2}$. Tests were also carried out on disks with $\mathrm{ZnS-cryolite}$ overcoated coatings, but the $\mathrm{Al_20_3}$ was not adhering well and the tests were not considered to be valid.

Because of the success of overcoated mirrors in raising the damage level of ${\rm LiNb0}_3$, we coated a ${\rm LiNb0}_3$ disk with a quarter-wave layer of ${\rm Al}_2{\rm O}_3$ and tested it. The damage threshold in this case was 150 MW/cm². The success of this experiment prompted us to try a ${\rm ZnS-ThF}_4$ multilayer with ${\rm Al}_2{\rm O}_3$ undercoating and overcoating. With this design it was hoped that the undercoating would protect the ${\rm LiNbO}_3$ and the overcoating would protect the mirror. On the first test we obtained damage at 86 MW/cm²; on subsequent tests, damage threshold was 150 MW/cm² or greater.

We can summarize these results as follows. Uncoated LiNbO is the most susceptible to damage, with a damage threshold of about 46 MW/cm 2 . Any coatings which are used on the LiNbO $_3$ increase this threshold. ZnS-2.hF $_4$ or ZnS-cryolite multilayers increase it moderately to approximately 60 MW/cm 2 . The use of Al $_2$ O $_3$ overcoatings and/or undercoatings increases it even further, giving thresholds of 110 to 150 MW/cm 2 .

6.3 THE CAUSE OF SMALL-SPOT DAMAGE

Before we give data on damage levels of the coatings which were fabricated and tested on this program, it is appropriate to consider the cause of the type of damage of Fig. 39d which we have termed small-spot damage. This type of damage is of particular interest since it occurs at lower power densities than the other types of damage; in the past it has been the major source of damage to $ZnS-ThF_4$ oscillator coatings. In connection with small-spot damage, we believe that (1) small-spot damage is damage to the top (ZnS) layer of a $ZnS-ThF_4$ or ZnS-cryolite coating, and (2) the damage is triggered by some change which takes place in this ZnS layer, such as oxidation to form a thin ZnO surface layer.

The experimental evidence which has led us to conclusion (1) is:

- (a) Small-spot damage is seen with both ZnS-ThF₄ and ZnS-cryolite coatings. For both coating types, the top layer is ZnS.
- (b) Small-spot damage is seen in a ZnS-ThF $_4$ multilayer which has ZnS as the top layer. Small-spot damage is not seen in a similar coating which has ThF $_4$ as the top layer.
- (c) Small-spot damage is observed in a coating which consists only of a quarter-wave layer of ZnS. Small-spot damage is not observed in a coating which is a quarter-wave layer of ThF_{L} .

The experimental evidence which has led us to conclusion (2) is:

(a) Susceptibility to small-spot damage can be greatly reduced by "scrubbing" the coating with a Q-tip moistened in acetone. Let us suppose that a damage test has just been performed in which substantial small-spot damage has occurred. The results of such a test are shown on line 1 of Fig. 40 where a row of small-spot damage can be seen. In this test, a power density of 76 MW/cm² was used on a ZnS-ThF₄ coating. The coating was then cleaned using a drop of acetone on a piece of lens tissue. The damage test was then repeated with the result shown in line 2 of Fig. 40; the damage is essentially the same as in line 1. Finally the coating was scrubbed using a Q-tip wetted with acetone, and the damage test repeated once more. As can be seen in line 3, small spot damage is completely gone (although lithium niobate damage and crater damage did occur). Thus

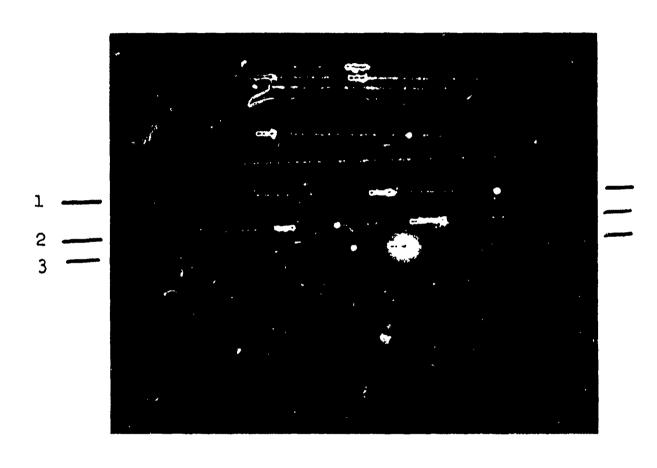


Figure 40 Damage tests performed in order to understand the behavior and cause of small-spot damage.

the Q-tip scrubbing increased the coating's resistance to small-spot damage, indicating that something has been removed from the surface of the top ZnS layer. The possibility that the presence of the acetone is somehow responsible for this effect can be ruled out by the results of lines (2) and (3) which show that light acetone scrubbing does not reduce small-spot damage, but firm acetone scrubbing does.

- (b) If this same coating is now left exposed to air for several days, its susceptibility to small-spot damage will gradually return and the entire cycle can once again be repeated.
- (c) Mirrors which are overcoated with ${\rm Al}_2{\rm O}_3$ do not exhibit small spot damage. With these mirrors, the top ZnS layer has never been exposed to air, being protected instead by ${\rm Al}_2{\rm O}_3$.

We surmise that perhaps oxidation of the ZnS top layer is responsible for this effect, but there is not yet any conclusive experimental justification. Shalimova, et al 19 have studied the oxidation of thin films of ZnS. They found that after 1 hour at a temperature of 550°-600°C, an oxide film appeared on the surface of a ZnS film. They also found that after 4 hours, a 1 micron thick ZnS film was completely oxidized. We are operating at much lower temperatures, of course, but the possibility still exists that a thin film of ZnO forms on the ZnS surface.

Since ZnS is a widely used coating material, we feel that this effect is of considerable potential importance. Even though we cannot presently state with certainty the cause, we can prescribe several ways of avoiding small-spot damage if a ZnS-ThF₄ or ZnS-cryolite coating is to be used. These are:

- (1) Use an $A1_20_3$ overcoating;
- (2) Make the top layer out of the other (non-ZnS) material.

If the top layer must be ZnS for some reason, then:

·(3) Scrub the coating and use it in an inert atmosphere, or simply rescrub the coating repeatedly.

6.4 COATING DAMAGE LEVELS

Damage tests were run on the various types of coatings using the apparatus of Fig. 13. The test conditions were the same as specified in Section 3.4, with the 1.08 micron laser operated in the TEM on mode. Damage levels for both small-spot damage (Fig. 39 c) and crater damage (Fig. 39 a) were recorded. The damage tests were performed by making a series of 0.100 inch long sweeps across the coating (using the micrometer translators) at succeedingly higher power levels. At each new power level, the mirror holder was translated 0.005 inches vertically. The result appears as a series of lines on the coating showing increasing damage. A typical result is shown in Fig. 41 where damage to a ZnS-cryolite coating is pictured. The numbers along the right-hand edge of the photo denote the average power outputs in mW of the Nd:YAlO laser. In Fig. 41, two craters can be seen, one occurring at the 250 mW level and the other at the 400 mW level. The rest of the damage in this photo is small-spot damage.

Small-spot damage was judged to occur when two or three spots could be found in a single line. The density of small-spot damage points increases at higher power levels, and thus one can determine fairly accurately the level at which this type of damage first occurred. Crater damage, on the other hand, is much more random in its occurrence. Sometimes one or two craters will occur at a certain power level, and then no more craters will appear until a considerably higher power level is reached. We have listed the first power level at which crater damage was observed in Table 4. Tests were performed with both fused quartz and lithium niobate substrates, with there being little difference in the results obtained for these two cases.

The data of Table 4 show that with ${\rm ZnS-ThF}_4$ and ${\rm ZnS-cryolite}$ coatings, small spot damage occurred at approximimately 38 to 46 MW/cm 2 . When overcoatings of ${\rm Al}_2{\rm O}_3$ were used, no small-spot damage was observed. These results are consistant with our hypothesis that small-spot damage occurs in the top ${\rm ZnS}$ layer of the coating.

Crater damage occurred in all the Lambda coatings at about 95 to $115~\mathrm{MW/cm}^2$. We believe that crater damage represents damage to an intermediate layer of the coating. We conjecture that it is an intermediate layer of ZnS

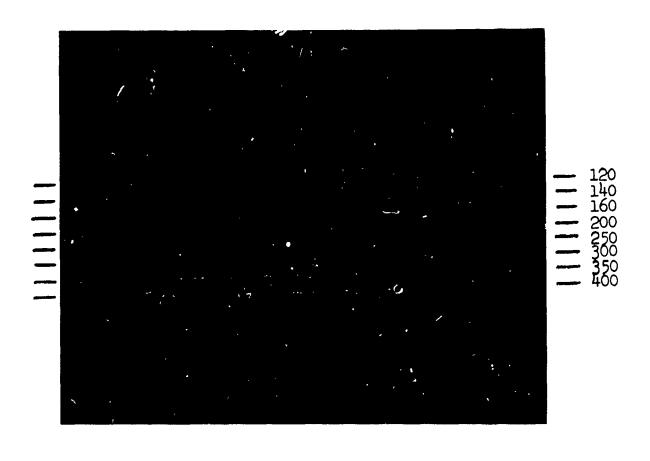


Figure 41 Typical result obtained from coating damage tests. The coating shown here was ZnS-cryolite on a fused quartz substrate. The magnification of this photograph is 28.

Table IV

Damage Levels of Multilayer Dielectric Coatings

Type of Coating	Power density at which small-spot damage occurred	Power density at which crater damage occurred
$z_{nS} - ThF_4$	$38 - 54 \text{ NW/cm}^2$	115 MW/cm ²
${ m ZnS}$ - ${ m ThF}_4$ overcoated with ${ m AI}_2{ m 0}_3$	no damage	107 kW/cm ²
ZnS-cryolite	$46 - 54 \text{ MW/cm}^2$	96 MW/cm ²
ZnS-cryolite overcoated with $\mathrm{Al_2}^{0}_3$	no damage	115 MW/cm ²
ZnS - ThF $_4$ undercoated and overcoated with ${ m Al}_2^{0}_3$	no damage	105 MW/cm ²
Spectrum Systems coatings	$< 10 \text{ MW/cm}^2$	$< 10 \text{ MW/cm}^2$

which causes this damage. In order to investigate this idea further, damage tests were performed on single quarter-wave layers of ZnS and ThF $_4$. No damage of any type was observed with ThF $_4$ up to 155 MW/cm 2 (our achievable upper limit). Small-spot damage occurred with the ZnS coating beginning at about 62 MW/cm 2 . Thus as also found by Turner 9 , ThF $_4$ is much more damage resistant than ZnS.

It is difficult, however, to determine exactly the damage threshold for pure ZnS. Our small-spot data (and possibly also Turner's data) probably gives damage levels for ZnO on ZnS rather than for pure ZnS. However it is possible that crater damage levels give this information for ZnS. Since ${\rm ThF}_4$ appears to have a high damage threshold, it is likely that intermediate layers of ZnS cause crater damage. If so, then pure ZnS damages at about 100 ${\rm MW/cm}^2$.

The Spectrum Systems coatings damaged at very low power densities, indicating that 1.08 micron absorption was occurring in one or both of the film materials. Perhaps the poor 1.08 micron transmission of Figs. 34 and 35 is partially due to absorption, as well as to reflection. The coatings damaged severely at 10 MW/cm, which was the lowest power density which we tried. Unless this absorption can be reduced to very low levels by further work, this type of mirror will be of no use in our oscillator work.

Section VII

OPTICAL PARAMETRIC OSCILLATOR EXPERIMENTS

Experiments were performed in which internal optical parametric oscillation was obtained using crystals with various types of coatings. The purposes of these experiments were (1) to provide conclusive evidence that the coatings under study were indeed appropriate for oscillator work, and (2) to study the damage characteristics of the coatings in an operating oscillator. Oscillation was obtained near degeneracy (near 2.16 microns) using several different types of coatings, and in the 2.8 to 3.8 micron range using ZnS-ThF₄ coatings. The internal oscillator form is shown in Fig. 2; a photograph of the oscillator is shown in Fig. 42. The laser utilizes a Nd:YAlO₃ rod which is continuously pumped by two tungsten-iodide lamps. The laser is repetitively Q-switched by means of a fused quartz acousto-optic Q-switch. The lithium niobate crystals used were similar to that shown in Fig. 3. Each crystal was approximately 5 mm in length.

7.1 2.16 MICRON OSCILLATOR EXPERIMENTS

Degenerate optical parametric oscillation was obtained from crystals with the following coatings: (a) ${\rm ZnS-ThF_4}$; (b) ${\rm ZnS-ThF_4}$ overcoated with ${\rm Al_2O_3}$; (c) ${\rm ZnS-cryolite}$; and (d) ${\rm ZnS-ThF_4}$ undercoated and overcoated with ${\rm Al_2O_3}$. Oscillation was not achieved with two other crystals. The coatings for the first unsuccessful crystal were ${\rm ZnS-cryolite}$ overcoated with ${\rm Al_2O_3}$. These coatings did not adhere well to the crystal; they began crazing and peeling immediately after they were received from Lambda. The second case in which oscillation could not be achieved was with the Spectrum Systems coatings. Here insertion of the coated crystal inside the laser extinguished it.

The following procedure was used on each of the oscillator tests. The oscillator was run continuously for a minimum of 10 hours. During this time the oscillator components were continually adjusted in order to (1) seek maximum output power, and (2) expose the entire coating area to damage. The crystal was translated a good deal in order to ensure that point (2) was met. The maximum output power was recorded in each case and is listed in Table 5.

Figure 42 Internal Optical Parametric Oscillator

Table V

Average 2-Micron Oscillator Output Powers Obtained using Crystals with Various Types of Coatings

Type of coating on crystal	Average 2 micron Output Power	
${ m ZnS-Th}F_{4}$	Мш 057	
${ m ZnS-ThF}_4$ overcoated with ${ m Al}_2{ m 0}_3$	l watt	
ZnS-cryolite	мш 006	
${ m ZnS-ThF}_4$ undercoated and overcoated with ${ m Al}_2{ m 0}_3$	Мш 056	
The second secon		

From Table 5 we see that substantial average output powers were obtained with each crystal. In order to establish some sort of reference, we note that 525 mW was the previous best output we had ever achieved under similar circumstances (5 mm long LiNbO₃ crystal, similar laser-cavity configuration). This was obtained about 1 year ago using ZnS-ThF₄ coatings on LiNbO₃. This value was essentially matched or exceeded in each oscillator experiment of Table 5. The smallest value (450 mW) was obtained with ZnS-ThF₄ mirrors, but the "blame" cannot be ascribed entirely to the mirrors. It is quite possible that some variation in optical quality from crystal to crystal might exist, or simply that the ZnS-ThF₄ oscillator was never adjusted quite as well as the others.

The excellent power outputs of Table 5 attest to the low-scatter character and good spectral transmittances of the various coatings tested. We now discuss how well these coatings fared on the third criteria - resistance to optical damage. We first note that this damage test differed from that of Section 3.4 in at least three important ways. First, in this test signal and idler wavelengths, as well as the pump, were present and could contribute to damage. Secondly, laser operation was in a high-order transverse mode with its attendant hot spots rather than a TEM on mode. A rough calculation shows that the peak 1.08 micron power density inside the laser is about 2 MW/cm². This is undoubtedly low, however, since it considers neither hot spots due to the multimode nature of the beam nor etalon effects due to the presence of the crystal inside the laser. Thirdly, during oscillator tests the LiNbO₃ and its coatings are heated to 100 to 150°C. Damage levels may be somewhat different at these temperatures than at room temperature.

Figure 43a shows photos (28 times magnification) taken of the ZnS-ThF $_4$ HR coating before and after this oscillator test. It can be seen that extensive small-spot damage occurred over most of the coating area. Moderate crater damage also occurred to both coatings on this crystal. After running this oscillator for 15 hours, there was a fall-off in its output power which is probably due to the rather severe small-spot damage encountered.

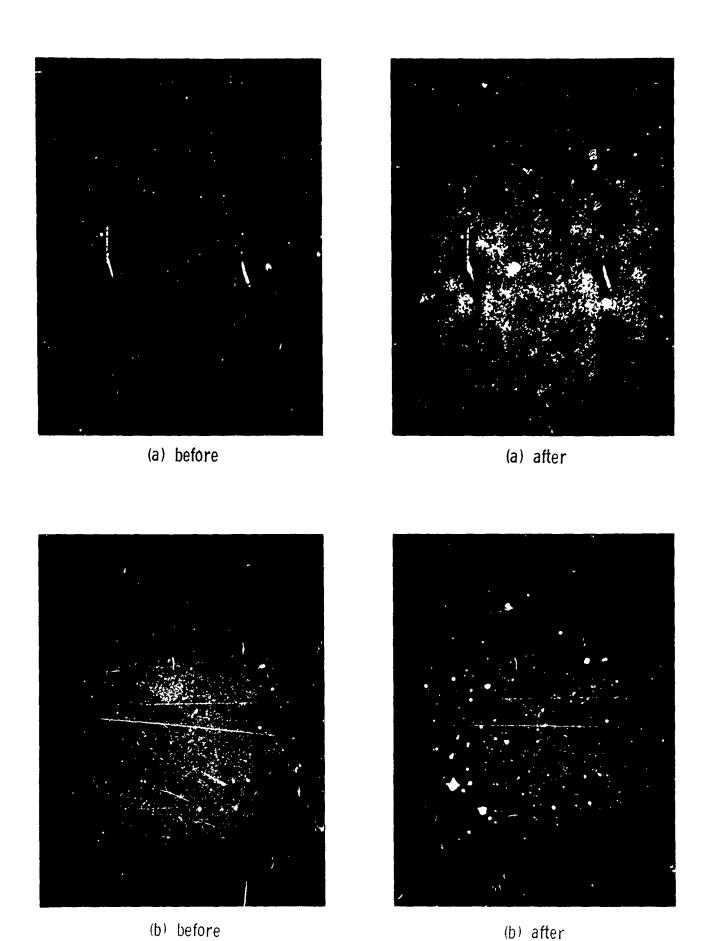


Figure 43 "Before" and "After" Damage photographs for 2-micron HR coatings a and b of (a) ZnS-ThF₄; (b) ZnS-ThF₄ overcoated with Al₂O₃

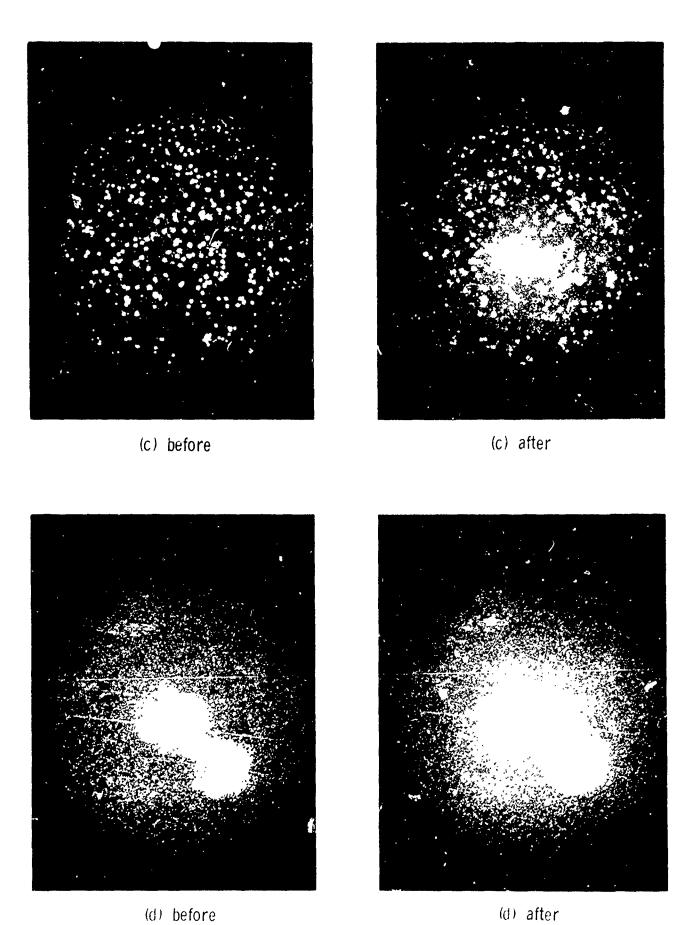


Figure 43 "Before" and "After" Damage photographs for 2-micron HR coatings of and d (c) ZnS-cryolite; and (d) ZnS-ThF₄ undercoated and overcoated with Al₂0₃.

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Figure 43b shows photos taken of the ZnS-ThF $_4$ coating overcoated with ${\rm Al}_2{\rm O}_3$ before and after parametric oscillation. No small spot damage can be seen indicating that the ${\rm Al}_2{\rm O}_3$ overcoating successfully inhibits its formation. Moderate crater damage is again present, with many of the craters being quite small in size. This indicates that intermediate-layer damage occurred in one of the upper layers in these instances. No degradation in oscillator power output was noticable during the course of this test.

Figure 43c shows photos taken of the ZnS-cryolite coating before and after oscillator tests. In the before photo, numerous blotches can be seen which appeared sometime during the 4 month period between the arrival of this coating from Lambda and its testing in an oscillator. These blotches were readily visible on the HR coating and very slightly visible on the transmitting coating. (The HR coating is pictured in Fig. 43c.) The blotches probably represent gradual deterioration of the ZnS-cryolite coating through absorption of moisture. We expected that the attainment of oscillation with the coating in this condition would not be possible. Surprisingly, however, the blotches did not adversely affect either the crystal insertion loss nor oscillator performance as evidenced by the 900 mW output which was obtained. The blotches do point up the fraility of this coating, however, compared to ${\rm ZnS-ThF}_{L}$ coatings. Figure 43c shows that moderate small-spot damage occurred. The extent of this small-spot damage was probably reduced by the fact that we had scru' bed the coating prior to this test in an attempt to remove the blotches. Moderate crater damage is also apparent from Fig. 43c.

Before and after photos of the ${\rm ZnS-ThF}_4$ undercoated and overcoated with ${\rm Al}_2{\rm O}_3$ are shown in Fig. 43d. From these photos, it can be seen that no small-spot damage occurred and that only minimal crater damage was present. This coating performed the best with respect to damage of the various coatings tried on this program. This type of coating is also satisfactory with respect to its other characteristics and thus appears to be a good choice for oscillator mirrors.

7.2 3 TO 4 MICRON OSCILLATOR EXPERIMENTS

Nondegenerate oscillator experiments were also performed using the setup of Fig. 42 and a 2.5 cm ${\rm LiNb0}_3$ crystal with ${\rm ZnS-ThF}_4$ singly-resonant coatings. Parametric oscillation was obtained from 2.8 to 3.8 microns, with average output powers ranging from 50 mW to 200 mW.

Before and after damage photos are shown in Fig. 44 for this coating. The coating was scrubbed with a Q-tip moistened with acetone just prior to this experiment in an attempt to minimize small spot damage. This undoubtedly helped, but as can be seen from Fig. 44 moderate small-spot damage and moderate crater damage were present. Thus the coating damage characteristics for the 3 to 4 micron oscillator are similar to those for the 2 micron oscillator. It is of interest to note that in all our oscillator coating-damage experiments, we did not encounter any ${\rm LiNb0}_3$ damage. This is not too surprizing for the ${\rm Al}_2{\rm O}_3$ overcoated coatings, but is rather surprising for the ${\rm ZnS-cr}_3$ olite and ${\rm ZnS-ThF}_4$ coatings. It is likely that if somewhat greater pump powers were used, we would begin to encounter ${\rm LiNb0}_3$ damage.

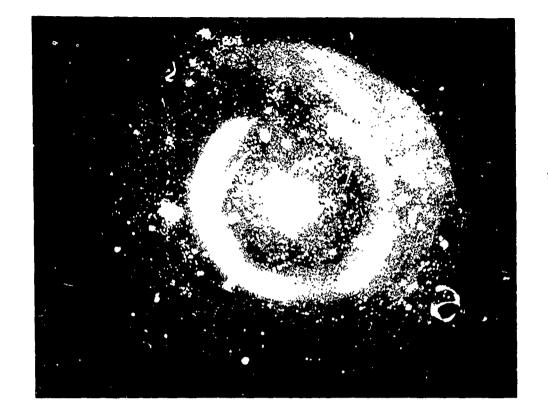


Figure 44 "Before" and "After" Damage photographs of ${\tt ZnS-ThF}_4$ coating for 3-micron singly resonant oscillator.



Section VIII

SUMMARY AND RECOMMENDATIONS FOR FURTHER WORK

The goal of this one-year program has been to develop mirrors which are suitable for use with optical parametric oscillators having outputs in the 1.5 to 4.5 micron region. The properties which we have sought for these mirrors are that they (1) have the correct reflectances at signal, idler, and pump wavelengths; (2) have very little scatter; and (3) have high resistance to optical damage. The mirrors which were studied on this program have been designed to be used in a LiNbO₃ parametric oscillator which is pumped by 1.08 microns (Nd:YA1O₃).

Several significant results were obtained on this program. These are:

- (1) Several different types of multilayer coatings for parametric oscillator mirrors were studied. These are listed and discussed in more detail below. The most satisfactory mirrors are composed of a ${\rm ZnS-ThF}_4$ multilayer which is undercoated and overcoated with single ${\rm Al}_2{\rm O}_3$ layers. The scatter and damage properties of this type of mirror are superior to those of previously available oscillator mirrors. Damage threshold(at 1.08 microns) is approximately ${\rm 110MW/cm}^2$
- (2) Surface damage studies were performed on coated and uncoated lithium niobate. It was found that the presence of mirrors having ${\rm Al}_2{}^0{}_3$ overcoatings raised the surface-damage threshold of lithium niobate by approximately a factor of three to a value of about 140 MW/cm 2 .
- (3) A source of coating damage which occurs when ZnS is the top layer of the coating was identified and studied. Several different methods were found for avoiding this type of damage. This result is important because of the widespread use of ZnS as a coating material. Furthermore this has previously been the main source of damage to oscillator coatings.
- (4) An explanation has been proposed for the much greater scatter present in coatings on lithium niobate than in coatings on fused quartz. We believe that the pyro-electric effect in lithium niobate causes charged dust particles to be attracted to the crystal surface during coating. Electro-static measurements were carried out and techniques suggested for eliminating this source of scatter.

As indicated above, several different types of multilayer coatings were fabricated and tested. These types are listed below along with our comments on each. The tests which were performed on each type of coating included (1) microscopic inspection to determine scatter properties, (2) the running of spectrophotometer traces in order to check spectral transmittances, (3) 1.08 micron damage threshold tests, and (4) the use of the coatings in an optical parametric oscillator. Lambda Optics and Coating, Inc. performed most of the actual coating work on this program as a subcontractor.

ZnS-ThF₄

This is the type of mirror which has predominantly been used in past oscillator work. These mirrors have reasonably low scatter, but there is still some variation in scatter encountered from lot to lot. ThF $_4$ is believed to be primarily responsible for this scatter. Sections 4.1 and 4.3 describe methods of minimizing this scatter. ZnS and ThF $_4$ are both well behaved materials during deposition, and hence the spectral characteristics of this type of mirror can be controlled. The primary disadvantage of this type of mirror is its susceptibility to damage. Damage to the top ZnS layer (small-spot damage) is severe while damage to intermediate ZnS layers (crater damage) is moderate.

${\rm ZnS-ThF}_4$ overcoated with ${\rm Al}_2{\rm O}_3$

This type of mirror has the good scatter and spectral characteristics of ${\rm ZnS-ThF}_4$ mirrors. Its damage properties are considerably better, however. Damage to the ${\rm ZnS}$ top layer is completely eliminated by the ${\rm Al}_2{\rm O}_3$ overcoating. Moderate damage to intermediate ${\rm ZnS}$ layers is still present however. This type of mirror shows all-around good performance.

2nS-cryolite

This type of mirror has the least scatter of those types tested on this program. Its spectral characteristics are easy to control since ZnS and cryolite are both very well-behaved materials. The damage characteristics are similar to those of ZnS-ThF $_4$ mirrors; thus severe top-layer ZnS damage and moderate intermediate-layer ZnS damage occur. An additional problem with this coating is its lack of durability. Both constituents are soft and susceptible to moisture. The ZnS-cryolite coating on one end of a LiNbO $_3$ oscillator crystal had numerous white blotches appear (see Fig. 43c) after five months of storage in a laboratory environment.

${\tt ZnS-cryolite~overcoated~with~Al}_2{\tt 0}_3$

This coating has the low scatter and good spectral properties of ZnS-cryolite coatings. The overcoating should produce improved damage properties, but has not done so yet because of coating adhesion problems. Reasonable idhesion of this coating has been achieved on fused quartz substrates, but very poor adhesion to LiNbO3. If this adhesion problem were soluble, these coatings might be of some interest.

$^{\mathrm{ZnS-ThF}_{4}}$ undercoated and overcoated with $^{\mathrm{Al}_{2}0}_{3}$

This coating has produced the best performance of those coatings studied on this program. The scatter and spectral properties are good, being again comparable to those of ZnS-ThF₄ coatings. The damage performance is the best of all coatings tested. Top-layer ZnS damage is precluded by the presence of the overcoating, and only slight damage is encountered in intermediate ZnS layers. The presence of the undercoating and overcoating seems to somewhat reduce the intermediate layer ZnS damage compared to that obtained with the overcoating alone. It is recommended that this type of coating be employed with 1-micron-pumped parametric oscillators whenever possible.

Hard coating by Spectrum Systems

The coatings listed above (except for the ${\rm Al}_2{}^0{}_3$ overcoating) are all composed of low melting point materials. Numerous other materials exist which have considerably higher melting points and which are more durable, but they

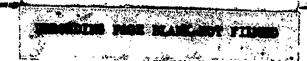
are also more difficult to deposit. One set of "hard" coatings was tried on this program; this set was fabricated by Spectrum Systems, Inc., but they would not disclose the materials involved.

Several of the general problems which are known to exist with respect to the fabrication of hard coatings did indeed occur. The first was with respect to spectral transmittance of the coatings. Transmission at the pump wavelength of 1.08 microns was only about 50%, rather than the desired 80% or more. In addition, scatter is somewhat worse for this coating than for those coatings already discussed. This is partially because Spectrum Systems heats the substrate to about 260°C during coating; the scatter due to the pyroelectric effect of LiNbO₃ (see Section 4.3) is thus more severe than if the substrates were not heated (as with Lambda's coatings). Finally, 1.08 micron damage occurred at very low power densities in these coatings indicating that absorption was present. These problems are perhaps soluble if considerable additional work is done on this type of coating. Hard coatings such as these hold considerable promise for oscillator applications, but much development remains before this potential is realized.

Measurements were also performed to determine the damage threshold of uncoated and coated ${\rm LiNb0}_3$. It was found that uncoated ${\rm LiNb0}_3$ damaged (1.08 microns) at about 45 MW/cm². The presence of ${\rm ZnS-ThF}_4$ or ${\rm ZnS-cryolite}$ coatings raised this to about 60 MW/cm². The presence of a mirror overcoated with ${\rm Al}_2{\rm O}_3$ increased this even further to 120-150 MW/cm². Thus ${\rm Al}_2{\rm O}_3$ overcoatings give protection not only to the coatings, but to the LiNbO3 substrate as well.

Let us now consider possible fruitful areas for further work in oscillator coatings. The coating which we found to be most suitable consists of ZnS-ThF₄ multilayers overcoated and undercoated with single Al₂O₃ layers. This type of coating works quite well for the present generation of infrared parametric oscillators. As oscillator output powers are increased still further, the limitation which will be reached with this coating will be damage to the intermediate layers of ZnS. There are two different approaches which can be tried in order to overcome this. (1) One can seek a (low-temperature) replacement material for ZnS. This material must be a high-index material and must have good scatter and spectral properties. Two possibilities are zinc selenide

(ZnSe) or ceric oxide (CeO₂). Both of these can be deposited using resistive-heating evaporation, and thus one avoids the various difficulties associated with high-temperature materials. (2) Employ high-temperature materials for the coating. This approach offers the possibility of eventually raising oscillator coating damage thresholds by a factor of 10 or more, whereas approach (1) would probably raise thresholds by a factor of 3 or so. The difficulties are also substantial, of course, but are not insurmountable. Possible thin-film combinations that could be tried with this approach include $\text{ZrO}_2\text{-SiO}_2$ and $\text{TiO}_2\text{-SiO}_2$. In both of these approaches, one would still strive to obtain coatings with low scatter, high damage thresholds, and controllable spectral transmittances.



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13. ABSTRACT

This report summarizes the results of a twelve-month program whose goal was to develop mirrors which are suitable for use with optical parametric oscillators having outputs in the 1.5 to 4.5 micron region. The properties which such mirrors must have are: (1) low scatter; (2) the correct spectral reflectances at signal, idler, and pump wavelengths; and (3) high resistance to optical damage. The mirrors which were studied on this program were designed for use with a lithium niobate parametric oscillator which is pumped by 1.08 microns. Several different types of multilayer coatings were fabricated and tested. These were ${\rm ZnS-ThF}_{L}$, ${\rm ZnS-ThF}_{\Delta}$ overcoated with ${\rm Al}_2{\rm O}_3$, ${\rm ZnS-cryolite}$, ${\rm ZnS-cryolite}$ overcoated with Al_2O_3 , $ZnS-ThF_4$ undercoated and overcoated with Al_2O_3 , and a "hard coating" of unknown composition. The tests which were performed on each coating included (1) microscopic inspection to determine scatter properties, (2) spectrophotometer traces to determine spectral transmittance, (3) 1.08 micron damage threshold tests, and (4) operation of an optical parametric oscillator using the coatings. Best overall results were obtained with mirrors composed of $ZnS-ThF_{\Lambda}$ undercoated and overcoated with Al₂0₃. Measurements were also performed to determine the surface-damage thresholds of uncoated and coated lithium niobate; it was found both soft (e.g. ZnS, ThF4, cryolite, etc.) and hard (e.g. ${\rm Al}_2{\rm O}_3$) coatings raise this threshold, with the greatest improvement effected by the Al203 coating.

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